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REMINDERS

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Please note that TAIYO YUDEN CO., LTD. shall not be responsible for any defects in products or equipment incorporating such products, which are caused under the conditions other than those specified in this catalog or individual specification.

- Please contact TAIYO YUDEN CO., LTD. for further details of product specifications as the individual specification is available.

- Please conduct validation and verification of products in actual condition of mounting and operating environment before commercial shipment of the equipment.

- All electronic components listed in this catalogue are intended for use in general electronic equipment such as AV/OA equipment, home electrical appliances, office equipment, information-communication equipment, general medical equipment, industrial equipment, and automotive applications.

Please be sure to contact TAIYO YUDEN CO., LTD. for further information before using the components for any equipment which might have a negative impact directly on human life, such as specially controlled medical equipment, transportation equipment (automotive powertrain/train/ship control systems, etc.) and traffic signal system.

Please do not incorporate the components into any equipment requiring a high degree of safety and reliability, such as aerospace equipment, avionics, nuclear control equipment, submarine system, and military equipment.

For use in high safety and reliability-required devices/circuits of general electronic equipment, thorough safety evaluation prior to use is strongly recommended, and a protective circuit should be designed and installed as necessary.

- The contents of this catalog are applicable to the products which are purchased from our sales offices or distributors (so called "TAIYO YUDEN's official sales channel").

It is only applicable to the products purchased from any of TAIYO YUDEN's official sales channel.

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- Caution for export

Certain items in this catalog may require specific procedures for export according to "Foreign Exchange and Foreign Trade Control Law" of Japan, "U.S. Export Administration Regulations", and other applicable regulations. Should you have any question or inquiry on this matter, please contact our sales staff.

MULTILAYER CERAMIC CAPACITORS



REFLOW

AEC-Q200

PART NUMBER

J	M	K	3	1	6	△	B	J	1	0	6	M	L	H	T	△
①	②	③	④	⑤	⑥	⑦	⑧	⑨	⑩	⑪	⑫					

△ = Blank space

① Rated voltage

Code	Rated voltage [VDC]
A	4
J	6.3
L	10
E	16
T	25
G	35
U	50
H	100
Q	250
S	630

② Series name

Code	Series name
M	Multilayer ceramic capacitor
W	LW reverse type multilayer capacitor

③ End termination

Code	End termination
K	Plated
R	High Reliability Application
J	Soft Termination

④ Dimension (L × W)

Type	Dimensions (L × W) [mm]	EIA (inch)
063	0.6 × 0.3	0201
105	1.0 × 0.5	0402
	0.52 × 1.0 ※	0204
107	1.6 × 0.8	0603
	0.8 × 1.6 ※	0306
212	2.0 × 1.25	0805
	1.25 × 2.0 ※	0508
316	3.2 × 1.6	1206
325	3.2 × 2.5	1210
432	4.5 × 3.2	1812

Note : ※LW reverse type (□WK) only

⑤ Dimension tolerance

Code	Type	L [mm]	W [mm]	T [mm]
△	ALL	Standard	Standard	Standard
A	063	0.6±0.05	0.3±0.05	0.3±0.05
	105	1.0±0.10	0.5±0.10	0.5±0.10
	107	1.6+0.15/-0.05	0.8+0.15/-0.05	0.8+0.15/-0.05
	212	2.0+0.15/-0.05	1.25+0.15/-0.05	0.85±0.10
	316	3.2±0.20	1.6±0.20	1.25+0.15/-0.05
	325	3.2±0.30	2.5±0.30	1.6±0.20
B	105	1.0+0.15/-0.05	0.5+0.15/-0.05	2.5±0.30
	107	1.6+0.20/-0	0.8+0.20/-0	0.5+0.15/-0.05
	212	2.0+0.20/-0	1.25+0.20/-0	0.8+0.20/-0
	316	3.2±0.30	1.6±0.30	0.85±0.10
C	105	1.0+0.20/-0	0.5+0.20/-0	1.25+0.20/-0
	212	2.0+0.25/-0	1.25+0.25/-0	1.6±0.30
K	212	2.0±0.15	1.25±0.15	0.5+0.20/-0
	325	3.2±0.50	2.5±0.30	1.25+0.25/-0

Note: P.32 Standard external dimensions

△ = Blank space

⑥ Temperature characteristics code

■ High dielectric type

Code	Applicable standard	Temperature range [°C]	Ref. Temp. [°C]	Capacitance change	Capacitance tolerance	Tolerance code
BJ	EIA	X5R	-55 ~ +85	±15%	±10%	K
					±20%	M
B7	EIA	X7R	-55 ~ +125	±15%	±10%	K
					±20%	M
C6	EIA	X6S	-55 ~ +105	±22%	±10%	K
					±20%	M
C7	EIA	X7S	-55 ~ +125	±22%	±10%	K
					±20%	M

■ Temperature compensating type

■ Temperature compensating type							
Code	Applicable standard		Temperature range[°C]	Ref. Temp.[°C]	Capacitance change	Capacitance tolerance	Tolerance code
CG	JIS	CG	-55~+125	20	0±30ppm/°C	±0.1pF	B
						±0.25pF	C
						±0.5pF	D
	EIA	C0G		25		±1pF	F
						±5%	J
						±10%	K

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⑦Nominal capacitance

Code (example)	Nominal capacitance
0R5	0.5pF
010	1pF
100	10pF
101	100pF
102	1,000pF
103	0.01 μ F
104	0.1 μ F
105	1.0 μ F
106	10 μ F
107	100 μ F

Note : R=Decimal point

⑧Capacitance tolerance

Code	Capacitance tolerance
B	± 0.1 pF
C	± 0.25 pF
D	± 0.5 pF
J	$\pm 5\%$
K	$\pm 10\%$
M	$\pm 20\%$

⑨Thickness

Code	Thickness[mm]
T	0.3
V	0.5
A	0.8
D	0.85(212type or more)
F	1.15
G	1.25
H	1.5
L	1.6
N	1.9
M	2.5

⑩Special code

Code	Special code
—	
H	MLCC for Industrial and Automotive

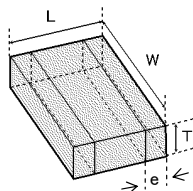
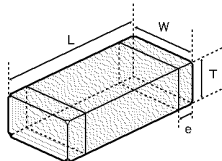
⑪Packaging

Code	Packaging
F	ϕ 178mm Taping (2mm pitch)
T	ϕ 178mm Taping (4mm pitch)
P	ϕ 178mm Taping (4mm pitch, 1000 pcs/reel) 325 type (Thickness code M)

⑫Internal code

Code	Internal code
Δ	Standard

■ STANDARD EXTERNAL DIMENSIONS



※ LW reverse type

Type(EIA)	Dimension [mm] (inch)				
	L	W	T	*1	e
□MK063 (0201)	0.6±0.03 (0.024±0.001)	0.3±0.03 (0.012±0.001)	0.3±0.03 (0.012±0.001)	T	0.15±0.05 (0.006±0.002)
□MK105 (0402)	1.0±0.05 (0.039±0.002)	0.5±0.05 (0.020±0.002)	0.5±0.05 (0.020±0.002)	V	0.25±0.10 (0.010±0.004)
□WK105 (0204) ※	0.52±0.05 (0.020±0.002)	1.0±0.05 (0.039±0.002)	0.3±0.05 (0.012±0.002)	P	0.18±0.08 (0.007±0.003)
□MK107 (0603)	1.6±0.10 (0.063±0.004)	0.8±0.10 (0.031±0.004)	0.8±0.10 (0.031±0.004)	A	0.35±0.25 (0.014±0.010)
□MR107 (0603)	1.6±0.10 (0.063±0.004)	0.8±0.10 (0.031±0.004)	0.8±0.10 (0.031±0.004)	A	0.1~0.6 (0.004~0.024)
□WK107 (0306) ※	0.8±0.10 (0.031±0.004)	1.6±0.10 (0.063±0.004)	0.5±0.05 (0.020±0.002)	V	0.25±0.15 (0.010±0.006)
□MK212 (0805)	2.0±0.10 (0.079±0.004)	1.25±0.10 (0.049±0.004)	0.85±0.10 (0.033±0.004)	D	0.5±0.25 (0.020±0.010)
			1.25±0.10 (0.049±0.004)	G	
□MR212 (0805)	2.0±0.10 (0.079±0.004)	1.25±0.10 (0.049±0.004)	1.25±0.10 (0.049±0.004)	G	0.25~0.75 (0.010~0.029)
□WK212 (0508) ※	1.25±0.15 (0.049±0.006)	2.0±0.15 (0.079±0.006)	0.85±0.10 (0.033±0.004)	D	0.3±0.2 (0.012±0.008)
□MK316 (1206)	3.2±0.15 (0.126±0.006)	1.6±0.15 (0.063±0.006)	1.15±0.10 (0.045±0.004)	F	0.5+0.35/-0.25 (0.020+0.014/-0.010)
			1.6±0.20 (0.063±0.008)	L	
□MR316 (1206)	3.2±0.15 (0.126±0.006)	1.6±0.15 (0.063±0.006)	1.6±0.20 (0.063±0.008)	L	0.25~0.85 (0.010~0.033)
□MK325 (1210)	3.2±0.30 (0.126±0.012)	2.5±0.20 (0.098±0.008)	1.15±0.10 (0.045±0.004)	F	0.6±0.3 (0.024±0.012)
			1.5±0.10 (0.059±0.004)	H	
			1.9±0.20 (0.075±0.008)	N	
			2.5±0.20 (0.098±0.008)	M	
□MR325 (1210)	3.2±0.30 (0.126±0.012)	2.5±0.20 (0.098±0.008)	1.9±0.20 (0.075±0.008)	N	0.3~0.9 (0.012~0.035)
			2.5±0.20 (0.098±0.008)	M	
□MK432 (1812)	4.5±0.40 (0.177±0.016)	3.2±0.30 (0.126±0.012)	2.5±0.20 (0.098±0.008)	M	0.9±0.6 (0.035±0.024)

Note : ※. LW reverse type, *1.Thickness code

■ STANDARD QUANTITY

Type	EIA (inch)	Dimension		Standard quantity [pcs]	
		[mm]	Code	Paper tape	Embossed tape
063	0201	0.3	T	15000	—
105	0402	0.5	V	10000	—
	0204 ※	0.30	P		
107	0603	0.8	A	4000	—
	0306 ※	0.50	V	—	4000
212	0805	0.85	D	4000	—
		1.25	G	—	3000
	0508 ※	0.85	D	4000	—
316	1206	1.15	F	—	3000
		1.6	L	—	2000
325	1210	1.15	F	—	2000
		1.5	H		
		1.9	N		
		2.5	M		
432	1812	2.5	M	—	500(T), 1000(P)

Note : ※.LW Reverse type(□WK)

PART NUMBER

● **AEC-Q200** : AEC-Q200 qualified

- All the Multilayer Ceramic Capacitors of Catalog Lineup are tested based on the test conditions and methods defined in AEC-Q200.
Please consult with TAIYO YUDEN's official sales channel for the details of the product specification and AEC-Q200 test results, etc.,
and please review and approve TAIYO YUDEN's product specification before ordering.
- All the Multilayer Ceramic Capacitors of Catalog Lineup are Compliance RoHS.
 - Capacitance tolerance code is applied to □ of part number.

Note)

- Information about usage environment or condition is necessary depending on the application and circuit condition. Please contact TAIYO YUDEN sales channels.
- *1: For standard case size, please kindly refer to ④Dimension, ⑤Dimension tolerance, ⑨Thickness and Standard external dimensions on Page 32.

Multilayer Ceramic Capacitors (High dielectric type)● **105TYPE (Dimension:1.0×0.5mm JIS:1005 EIA:0402)**

【Temperature Characteristic BJ : X5R】 0.5mm thickness (V)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMK105 BJ102□VHF		50	X5R	1000 p	±10, ±20	2.5	200	0.5±0.05	R
UMK105 BJ152□VHF			X5R	1500 p	±10, ±20	2.5	200	0.5±0.05	R
UMK105 BJ222□VHF			X5R	2200 p	±10, ±20	2.5	200	0.5±0.05	R
UMK105 BJ332□VHF			X5R	3300 p	±10, ±20	2.5	200	0.5±0.05	R
UMK105 BJ472□VHF			X5R	4700 p	±10, ±20	2.5	200	0.5±0.05	R
UMK105 BJ682□VHF			X5R	6800 p	±10, ±20	2.5	150	0.5±0.05	R
UMK105 BJ103□VHF			X5R	0.01 μ	±10, ±20	3.5	200	0.5±0.05	R
UMK105 BJ223□VHF			X5R	0.022 μ	±10, ±20	10	150	0.5±0.05	R
UMK105 BJ473□VHF			X5R	0.047 μ	±10, ±20	10	150	0.5±0.05	R
UMK105 BJ104□VHF			X5R	0.1 μ	±10, ±20	10	150	0.5±0.05	R
TMK105 BJ472□VHF		25	X5R	4700 p	±10, ±20	2.5	200	0.5±0.05	R
TMK105 BJ682□VHF			X5R	6800 p	±10, ±20	2.5	200	0.5±0.05	R
TMK105 BJ103□VHF			X5R	0.01 μ	±10, ±20	3.5	200	0.5±0.05	R
TMK105 BJ223□VHF			X5R	0.022 μ	±10, ±20	3.5	200	0.5±0.05	R
TMK105 BJ473□VHF			X5R	0.047 μ	±10, ±20	3.5	150	0.5±0.05	R
TMK105 BJ104□VHF			X5R	0.1 μ	±10, ±20	5	150	0.5±0.05	R
TMK105 BJ224□VHF			X5R	0.22 μ	±10, ±20	10	150	0.5±0.05	R
TMK105ABJ474□VHF			X5R	0.47 μ	±10, ±20	10	150	0.5±0.10	R
EMK105 BJ223□VHF		16	X5R	0.022 μ	±10, ±20	3.5	200	0.5±0.05	R
EMK105 BJ473□VHF			X5R	0.047 μ	±10, ±20	3.5	150	0.5±0.05	R
EMK105 BJ104□VHF			X5R	0.1 μ	±10, ±20	5	150	0.5±0.05	R
EMK105 BJ224□VHF			X5R	0.22 μ	±10, ±20	10	150	0.5±0.05	R
EMK105ABJ474□VHF			X5R	0.47 μ	±10, ±20	10	150	0.5±0.10	R
EMK105 BJ105□VHF		10	X5R	1 μ	±10, ±20	10	150	0.5±0.05	R
LMK105 BJ224□VHF			X5R	0.22 μ	±10, ±20	5	150	0.5±0.05	R
LMK105ABJ474□VHF			X5R	0.47 μ	±10, ±20	10	150	0.5±0.10	R
LMK105 BJ105□VHF			X5R	1 μ	±10, ±20	10	150	0.5±0.05	R
LMK105ABJ225MVHF			X5R	2.2 μ	±20	10	150	0.5±0.10	R
JMK105 BJ224□VHF		6.3	X5R	0.22 μ	±10, ±20	5	150	0.5±0.05	R
JMK105 BJ474□VHF			X5R	0.47 μ	±10, ±20	10	150	0.5±0.05	R
JMK105 BJ105□VHF			X5R	1 μ	±10, ±20	10	150	0.5±0.05	R
JMK105 BJ225MVHF			X5R	2.2 μ	±20	10	150	0.5±0.05	R
JMK105BBJ475MVHF			X5R	4.7 μ	±20	10	150	0.5+0.15/-0.05	R
AMK105 BJ225MVHF		4	X5R	2.2 μ	±20	10	150	0.5±0.05	R
AMK105BBJ475MVHF			X5R	4.7 μ	±20	10	150	0.5+0.15/-0.05	R
AMK105CBJ106MVHF			X5R	10 μ	±20	10	150	0.5+0.20/-0	R

【Temperature Characteristic B7 : X7R】 0.5mm thickness (V)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMK105 B7102□VHF		50	X7R	1000 p	±10, ±20	2.5	200	0.5±0.05	R
UMK105 B7152□VHF			X7R	1500 p	±10, ±20	2.5	200	0.5±0.05	R
UMK105 B7222□VHF			X7R	2200 p	±10, ±20	2.5	200	0.5±0.05	R
UMK105 B7332□VHF			X7R	3300 p	±10, ±20	2.5	200	0.5±0.05	R
UMK105 B7472□VHF			X7R	4700 p	±10, ±20	2.5	150	0.5±0.05	R
UMK105 B7682□VHF			X7R	6800 p	±10, ±20	2.5	150	0.5±0.05	R
UMK105 B7103□VHF			X7R	0.01 μ	±10, ±20	3.5	150	0.5±0.05	R
UMK105 B7223□VHF			X7R	0.022 μ	±10, ±20	10	150	0.5±0.05	R
UMK105 B7473□VHF			X7R	0.047 μ	±10, ±20	10	150	0.5±0.05	R
UMK105 B7104□VHF			X7R	0.1 μ	±10, ±20	10	150	0.5±0.05	R
TMK105 B7472□VHF		25	X7R	4700 p	±10, ±20	2.5	200	0.5±0.05	R
TMK105 B7682□VHF			X7R	6800 p	±10, ±20	2.5	200	0.5±0.05	R
TMK105 B7103□VHF			X7R	0.01 μ	±10, ±20	3.5	200	0.5±0.05	R
TMK105 B7104□VHF			X7R	0.1 μ	±10, ±20	10	150	0.5±0.05	R
EMK105 B7223□VHF		16	X7R	0.022 μ	±10, ±20	3.5	150	0.5±0.05	R
EMK105 B7473□VHF			X7R	0.047 μ	±10, ±20	3.5	150	0.5±0.05	R
EMK105 B7104□VHF			X7R	0.1 μ	±10, ±20	5	150	0.5±0.05	R
EMK105 B7224□VHF			X7R	0.22 μ	±10, ±20	10	150	0.5±0.05	R
LMK105 B7104□VHF		10	X7R	0.1 μ	±10, ±20	5	150	0.5±0.05	R
LMK105 B7224□VHF			X7R	0.22 μ	±10, ±20	10	150	0.5±0.05	R
JMK105 B7224□VHF		6.3	X7R	0.22 μ	±10, ±20	10	150	0.5±0.05	R
JMK105 B7474□VHF			X7R	0.47 μ	±10, ±20	10	150	0.5±0.05	R

● **107TYPE (Dimension:1.6×0.8mm JIS:1608 EIA:0603)**

【Temperature Characteristic BJ : X5R】 0.8mm thickness (A)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMK107 BJ104□AHT		50	X5R	0.1 μ	±10, ±20	3.5	150	0.8±0.10	R
UMK107 BJ224□AHT			X5R	0.22 μ	±10, ±20	10	150	0.8±0.10	R
UMK107 BJ474□AHT			X5R	0.47 μ	±10, ±20	10	150	0.8±0.10	R
UMK107ABJ105□AHT			X5R	1 μ	±10, ±20	10	150	0.8±0.10	R
GMK107 BJ223□AHT		35	X5R	0.022 μ	±10, ±20	2.5	200	0.8±0.10	R
GMK107 BJ473□AHT			X5R	0.047 μ	±10, ±20	3.5	200	0.8±0.10	R
GMK107 BJ104□AHT			X5R	0.1 μ	±10, ±20	3.5	150	0.8±0.10	R
GMK107 BJ224□AHT			X5R	0.22 μ	±10, ±20	10	150	0.8±0.10	R
GMK107ABJ474□AHT			X5R	0.47 μ	±10, ±20	10	150	0.8+0.15/-0.05	R
GMK107 BJ105□AHT			X5R	1 μ	±10, ±20	10	150	0.8±0.10	R

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PART NUMBER

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
TMK107 BJ223[AHT]		25	X5R	0.022 μ	±10, ±20	2.5	200	0.8±0.10	R
TMK107 BJ473[AHT]			X5R	0.047 μ	±10, ±20	3.5	200	0.8±0.10	R
TMK107 BJ104[AHT]			X5R	0.1 μ	±10, ±20	3.5	150	0.8±0.10	R
TMK107 BJ224[AHT]			X5R	0.22 μ	±10, ±20	5	150	0.8±0.10	R
TMK107 BJ474[AHT]			X5R	0.47 μ	±10, ±20	3.5	150	0.8±0.10	R
TMK107 BJ105[AHT]			X5R	1 μ	±10, ±20	10	150	0.8±0.10	R
TMK107BBJ225[AHT]			X5R	2.2 μ	±10, ±20	10	150	0.8+0.20/-0	R
EMK107 BJ104[AHT]		16	X5R	0.1 μ	±10, ±20	3.5	150	0.8±0.10	R
EMK107 BJ224[AHT]			X5R	0.22 μ	±10, ±20	5	150	0.8±0.10	R
EMK107 BJ474[AHT]			X5R	0.47 μ	±10, ±20	3.5	150	0.8±0.10	R
EMK107 BJ105[AHT]			X5R	1 μ	±10, ±20	5	150	0.8±0.10	R
EMK107ABJ225[AHT]			X5R	2.2 μ	±10, ±20	10	150	0.8+0.15/-0.05	R
EMK107BBJ475[AHT]			X5R	4.7 μ	±10, ±20	10	150	0.8+0.20/-0	R
LMK107 BJ474[AHT]			X5R	0.47 μ	±10, ±20	3.5	150	0.8±0.10	R
LMK107 BJ105[AHT]		10	X5R	1 μ	±10, ±20	5	150	0.8±0.10	R
LMK107 BJ225[AHT]			X5R	2.2 μ	±10, ±20	10	150	0.8±0.10	R
LMK107 BJ475[AHT]			X5R	4.7 μ	±10, ±20	10	150	0.8±0.10	R
LMK107BBJ106MAHT			X5R	10 μ	±20	10	150	0.8+0.20/-0	R
JMK107 BJ225[AHT]			X5R	2.2 μ	±10, ±20	10	150	0.8±0.10	R
JMK107 BJ475[AHT]		6.3	X5R	4.7 μ	±10, ±20	10	150	0.8±0.10	R
JMK107ABJ106MAHT			X5R	10 μ	±20	10	150	0.8+0.15/-0.05	R
AMK107ABJ106MAHT			X5R	10 μ	±20	10	150	0.8+0.15/-0.05	R
AMK107BBJ226MAHT		4	X5R	22 μ	±20	10	150	0.8+0.20/-0	R
			X5R	22 μ	±20	10	150	0.8+0.20/-0	R

[Temperature Characteristic B7 : X7R, C7 : X7S] 0.8mm thickness (A)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMK107 B7102[AHT]		50	X7R	1000 p	±10, ±20	3.5	200	0.8±0.10	R
UMK107 B7152[AHT]			X7R	1500 p	±10, ±20	3.5	200	0.8±0.10	R
UMK107 B7222[AHT]			X7R	2200 p	±10, ±20	3.5	200	0.8±0.10	R
UMK107 B7332[AHT]			X7R	3300 p	±10, ±20	3.5	200	0.8±0.10	R
UMK107 B7472[AHT]			X7R	4700 p	±10, ±20	3.5	200	0.8±0.10	R
UMK107 B7682[AHT]			X7R	6800 p	±10, ±20	3.5	200	0.8±0.10	R
UMK107 B7103[AHT]			X7R	0.01 μ	±10, ±20	3.5	200	0.8±0.10	R
UMK107 B7223[AHT]			X7R	0.022 μ	±10, ±20	3.5	200	0.8±0.10	R
UMK107 B7473[AHT]			X7R	0.047 μ	±10, ±20	3.5	200	0.8±0.10	R
UMK107 B7104[AHT]			X7R	0.1 μ	±10, ±20	3.5	200	0.8±0.10	R
GMK107 B7473[AHT]		35	X7R	0.047 μ	±10, ±20	3.5	200	0.8±0.10	R
GMK107 B7104[AHT]			X7R	0.1 μ	±10, ±20	3.5	150	0.8±0.10	R
GMK107 B7224[AHT]			X7R	0.22 μ	±10, ±20	10	150	0.8±0.10	R
GMK107 B7474[AHT]			X7R	0.47 μ	±10, ±20	10	150	0.8±0.10	R
GMK107AB7105[AHT]			X7R	1 μ	±10, ±20	10	150	0.8+0.15/-0.05	R
TMK107 B7223[AHT]		25	X7R	0.022 μ	±10, ±20	2.5	200	0.8±0.10	R
TMK107 B7473[AHT]			X7R	0.047 μ	±10, ±20	3.5	200	0.8±0.10	R
TMK107 B7104[AHT]			X7R	0.1 μ	±10, ±20	3.5	150	0.8±0.10	R
TMK107 B7224[AHT]			X7R	0.22 μ	±10, ±20	10	150	0.8±0.10	R
TMK107 B7474[AHT]			X7R	0.47 μ	±10, ±20	10	150	0.8±0.10	R
TMK107AB7105[AHT]		16	X7R	1 μ	±10, ±20	10	150	0.8+0.15/-0.05	R
EMK107 B7473[AHT]			X7R	0.047 μ	±10, ±20	3.5	200	0.8±0.10	R
EMK107 B7104[AHT]			X7R	0.1 μ	±10, ±20	3.5	150	0.8±0.10	R
EMK107 B7224[AHT]			X7R	0.22 μ	±10, ±20	5	150	0.8±0.10	R
EMK107 B7474[AHT]			X7R	0.47 μ	±10, ±20	10	150	0.8±0.10	R
EMK107 B7105[AHT]		10	X7R	1 μ	±10, ±20	10	150	0.8±0.10	R
LMK107 B7224[AHT]			X7R	0.22 μ	±10, ±20	5	150	0.8±0.10	R
LMK107 B7474[AHT]			X7R	0.47 μ	±10, ±20	3.5	150	0.8±0.10	R
LMK107 B7105[AHT]			X7R	1 μ	±10, ±20	10	150	0.8±0.10	R
JMK107 C7225[AHT]		6.3	X7S	2.2 μ	±10, ±20	10	150	0.8±0.10	R

212TYPE (Dimension:2.0×1.25mm JIS:2012 EIA:0805)

[Temperature Characteristic BJ : X5R] 1.25mm thickness (G)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMK212 BJ104[GHT]		50	X5R	0.1 μ	±10, ±20	3.5	200	1.25±0.10	R
UMK212 BJ224[GHT]			X5R	0.22 μ	±10, ±20	3.5	150	1.25±0.10	R
UMK212 BJ474[GHT]			X5R	0.47 μ	±10, ±20	3.5	150	1.25±0.10	R
UMK212 BJ105[GHT]			X5R	1 μ	±10, ±20	5	150	1.25±0.10	R
GMK212 BJ104[GHT]			X5R	0.1 μ	±10, ±20	3.5	200	1.25±0.10	R
GMK212 BJ224[GHT]		35	X5R	0.22 μ	±10, ±20	3.5	150	1.25±0.10	R
GMK212 BJ474[GHT]			X5R	0.47 μ	±10, ±20	3.5	150	1.25±0.10	R
GMK212 BJ105[GHT]			X5R	1 μ	±10, ±20	5	150	1.25±0.10	R
GMK212BBJ225[GHT]			X5R	2.2 μ	±10, ±20	10	150	1.25+0.20/-0	R
TMK212 BJ104[GHT]		25	X5R	0.1 μ	±10, ±20	3.5	200	1.25±0.10	R
TMK212 BJ224[GHT]			X5R	0.22 μ	±10, ±20	3.5	150	1.25±0.10	R
TMK212 BJ474[GHT]			X5R	0.47 μ	±10, ±20	3.5	200	1.25±0.10	R
TMK212 BJ105[GHT]			X5R	1 μ	±10, ±20	3.5	150	1.25±0.10	R
TMK212 BJ225[GHT]			X5R	2.2 μ	±10, ±20	5	150	1.25±0.10	R
TMK212BBJ475[GHT]		16	X5R	4.7 μ	±10, ±20	10	150	1.25+0.20/-0	R
TMK212BBJ106[GHT]			X5R	10 μ	±10, ±20	10	150	1.25+0.20/-0	R
EMK212 BJ105[GHT]			X5R	1 μ	±10, ±20	3.5	150	1.25±0.10	R
EMK212 BJ225[GHT]			X5R	2.2 μ	±10, ±20	5	200	1.25±0.10	R
EMK212ABJ475[GHT]			X5R	4.7 μ	±10, ±20	10	150	1.25+0.15/-0.05	R
EMK212BBJ106[GHT]		10	X5R	10 μ	±10, ±20	10	150	1.25+0.20/-0	R
LMK212 BJ225[GHT]			X5R	2.2 μ	±10, ±20	5	200	1.25±0.10	R
LMK212ABJ475[GHT]			X5R	4.7 μ	±10, ±20	10	150	1.25+0.15/-0.05	R
LMK212ABJ106[GHT]			X5R	10 μ	±10, ±20	10	150	1.25+0.15/-0.05	R
JMK212ABJ475[GHT]			X5R	4.7 μ	±10, ±20	5	200	1.25+0.15/-0.05	R
JMK212ABJ106[GHT]		6.3	X5R	10 μ	±10, ±20	10	150	1.25+0.15/-0.05	R
JMK212BBJ226MGHT			X5R	22 μ	±20	10	150	1.25+0.20/-0	R
AMK212ABJ226MGHT			X5R	22 μ	±20	10	150	1.25+0.15/-0.05	R
AMK212BBJ476MGHT		4	X5R	47 μ	±20	10	150	1.25+0.20/-0	R

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PART NUMBER

[Temperature Characteristic BJ : X5R] 0.85mm thickness (D)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
EMK212 BJ105□DHT		16	X5R	1 μ	±10, ±20	5	200	0.85±0.10	R
EMK212ABJ225□DHT			X5R	2.2 μ	±10, ±20	5	150	0.85±0.10	R
EMK212BBJ475□DHT			X5R	4.7 μ	±10, ±20	10	150	0.85±0.10	R

[Temperature Characteristic B7 : X7R] 1.25mm thickness (G)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMK212 B7103□GHT		50	X7R	0.01 μ	±10, ±20	3.5	200	1.25±0.10	R
UMK212 B7223□GHT			X7R	0.022 μ	±10, ±20	3.5	200	1.25±0.10	R
UMK212 B7473□GHT			X7R	0.047 μ	±10, ±20	3.5	200	1.25±0.10	R
UMK212 B7104□GHT			X7R	0.1 μ	±10, ±20	3.5	200	1.25±0.10	R
UMK212 B7224□GHT			X7R	0.22 μ	±10, ±20	3.5	150	1.25±0.10	R
UMK212 B7105□GHT		35	X7R	1 μ	±10, ±20	10	150	1.25±0.10	R
GMK212 B7224□GHT			X7R	0.22 μ	±10, ±20	3.5	150	1.25±0.10	R
GMK212 B7105□GHT			X7R	1 μ	±10, ±20	10	150	1.25±0.10	R
TMK212 B7224□GHT		25	X7R	0.22 μ	±10, ±20	3.5	150	1.25±0.10	R
TMK212 B7474□GHT			X7R	0.47 μ	±10, ±20	3.5	150	1.25±0.10	R
TMK212 B7105□GHT			X7R	1 μ	±10, ±20	3.5	150	1.25±0.10	R
TMK212 B7225□GHT			X7R	2.2 μ	±10, ±20	10	150	1.25±0.10	R
EMK212 B7224□GHT		16	X7R	0.22 μ	±10, ±20	3.5	150	1.25±0.10	R
EMK212 B7474□GHT			X7R	0.47 μ	±10, ±20	3.5	150	1.25±0.10	R
EMK212 B7105□GHT			X7R	1 μ	±10, ±20	3.5	150	1.25±0.10	R
EMK212 B7225□GHT			X7R	2.2 μ	±10, ±20	10	150	1.25±0.10	R
EMK212AB7475□GHT			X7R	4.7 μ	±10, ±20	10	150	1.25±0.15/-0.05	R
LMK212 B7105□GHT		10	X7R	1 μ	±10, ±20	3.5	150	1.25±0.10	R
LMK212 B7225□GHT			X7R	2.2 μ	±10, ±20	10	150	1.25±0.10	R
LMK212 B7475□GHT			X7R	4.7 μ	±10, ±20	10	150	1.25±0.10	R
JMK212AB7106□GHT		6.3	X7R	10 μ	±10, ±20	10	150	1.25±0.15/-0.05	R

● 316TYPE (Dimension:3.2×1.6mm JIS:3216 EIA:1206)

[Temperature Characteristic BJ : X5R] 1.6mm thickness (L)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMK316 BJ474□LHT		50	X5R	0.47 μ	±10, ±20	3.5	200	1.6±0.20	R
UMK316 BJ105□LHT			X5R	1 μ	±10, ±20	3.5	200	1.6±0.20	R
UMK316 BJ225□LHT			X5R	2.2 μ	±10, ±20	10	150	1.6±0.20	R
UMK316ABJ475□LHT			X5R	4.7 μ	±10, ±20	10	150	1.6±0.20	R
GMK316 BJ105□LHT		35	X5R	1 μ	±10, ±20	3.5	200	1.6±0.20	R
GMK316 BJ225□LHT			X5R	2.2 μ	±10, ±20	10	150	1.6±0.20	R
GMK316 BJ475□LHT			X5R	4.7 μ	±10, ±20	10	150	1.6±0.20	R
TMK316 BJ225□LHT			X5R	2.2 μ	±10, ±20	3.5	200	1.6±0.20	R
TMK316 BJ475□LHT		25	X5R	4.7 μ	±10, ±20	5	150	1.6±0.20	R
TMK316 BJ106□LHT			X5R	10 μ	±10, ±20	5	150	1.6±0.20	R
EMK316 BJ225□LHT		16	X5R	2.2 μ	±10, ±20	3.5	200	1.6±0.20	R
EMK316 BJ475□LHT			X5R	4.7 μ	±10, ±20	5	150	1.6±0.20	R
EMK316 BJ106□LHT			X5R	10 μ	±10, ±20	5	150	1.6±0.20	R
EMK316BBJ226MLHT			X5R	22 μ	±20	10	150	1.6±0.30	R
LMK316 BJ475□LHT		10	X5R	4.7 μ	±10, ±20	5	150	1.6±0.20	R
LMK316 BJ106□LHT			X5R	10 μ	±10, ±20	5	150	1.6±0.20	R
LMK316ABJ226□LHT			X5R	22 μ	±10, ±20	10	150	1.6±0.20	R
JMK316 BJ106□LHT		6.3	X5R	10 μ	±10, ±20	5	200	1.6±0.20	R
JMK316ABJ226□LHT			X5R	22 μ	±10, ±20	10	150	1.6±0.20	R
JMK316ABJ476MLHT			X5R	47 μ	±20	10	150	1.6±0.20	R
JMK316BBJ107MLHT			X5R	100 μ	±20	10	150	1.6±0.30	R
AMK316ABJ107MLHT		4	X5R	100 μ	±20	10	150	1.6±0.20	R

[Temperature Characteristic B7 : X7R, C7 : X7S] 1.6mm thickness (L)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMK316 B7473□LHT		50	X7R	0.047 μ	±10, ±20	3.5	200	1.6±0.20	R
UMK316 B7104□LHT			X7R	0.1 μ	±10, ±20	3.5	200	1.6±0.20	R
UMK316 B7224□LHT			X7R	0.22 μ	±10, ±20	3.5	200	1.6±0.20	R
UMK316 B7474□LHT			X7R	0.47 μ	±10, ±20	3.5	200	1.6±0.20	R
UMK316 B7105□LHT			X7R	1 μ	±10, ±20	3.5	200	1.6±0.20	R
UMK316 B7225□LHT		35	X7R	2.2 μ	±10, ±20	10	150	1.6±0.20	R
GMK316 B7105□LHT			X7R	1 μ	±10, ±20	3.5	200	1.6±0.20	R
GMK316 B7225□LHT			X7R	2.2 μ	±10, ±20	10	150	1.6±0.20	R
GMK316AB7475□LHT			X7R	4.7 μ	±10, ±20	10	150	1.6±0.20	R
TMK316 B7225□LHT		25	X7R	2.2 μ	±10, ±20	3.5	200	1.6±0.20	R
TMK316AB7475□LHT			X7R	4.7 μ	±10, ±20	10	150	1.6±0.20	R
TMK316AB7106□LHT			X7R	10 μ	±10, ±20	10	150	1.6±0.20	R
EMK316 B7225□LHT			X7R	2.2 μ	±10, ±20	3.5	200	1.6±0.20	R
EMK316AB7475□LHT		16	X7R	4.7 μ	±10, ±20	10	150	1.6±0.20	R
EMK316AB7106□LHT			X7R	10 μ	±10, ±20	10	150	1.6±0.20	R
LMK316 B7475□LHT			X7R	4.7 μ	±10, ±20	5	150	1.6±0.20	R
LMK316AB7106□LHT		10	X7R	10 μ	±10, ±20	10	150	1.6±0.20	R
JMK316AB7106□LHT			X7R	10 μ	±10, ±20	10	150	1.6±0.20	R
JMK316AB7226□LHT			X7R	22 μ	±10, ±20	10	150	1.6±0.20	R
AMK316AB7226□LHT		4	X7R	22 μ	±10, ±20	10	150	1.6±0.20	R
AMK316AC7476□LHT			X7S	47 μ	±10, ±20	10	150	1.6±0.20	R

● 325TYPE (Dimension:3.2×2.5mm JIS:3225 EIA:1210)

[Temperature Characteristic BJ : X5R] 2.5mm thickness (M)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMK325 BJ106□MHT		50	X5R	10 μ	±10, ±20	5	150	2.5±0.20	R
GMK325 BJ106□MHT		35	X5R	10 μ	±10, ±20	5	150	2.5±0.20	R
TMK325 BJ106□MHT		25	X5R	10 μ	±10, ±20	5	150	2.5±0.20	R
EMK325 BJ226□MHT		16	X5R	22 μ	±10, ±20	5	150	2.5±0.20	R

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PART NUMBER

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
LMK325 BJ226□MHT		10	X5R	22 μ	±10, ±20	5	150	2.5±0.20	R
LMK325 BJ476MMHT			X5R	47 μ	±20	10	150	2.5±0.20	R
LMK325ABJ107MMHT			X5R	100 μ	±20	10	150	2.5±0.30	R
JMK325 BJ476MMHT		6.3	X5R	47 μ	±20	10	150	2.5±0.20	R
JMK325ABJ107MMHT			X5R	100 μ	±20	10	150	2.5±0.30	R
AMK325ABJ107MMHT			X5R	100 μ	±20	10	150	2.5±0.30	R
AMK325ABJ227MMHT		4	X5R	220 μ	±20	10	150	2.5±0.30	R

[Temperature Characteristic BJ : X5R] 1.9mm thickness (N)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMK325 BJ475□NHT		50	X5R	4.7 μ	±10, ±20	10	150	1.9±0.20	R
GMK325 BJ225MNHT		35	X5R	2.2 μ	±20	3.5	200	1.9±0.20	R
GMK325 BJ475□NHT			X5R	4.7 μ	±10, ±20	10	150	1.9±0.20	R
TMK325 BJ475□NHT		25	X5R	4.7 μ	±10, ±20	10	150	1.9±0.20	R
EMK325 BJ475MNHT		16	X5R	4.7 μ	±20	3.5	200	1.9±0.20	R
EMK325 BJ106□NHT			X5R	10 μ	±10, ±20	5	150	1.9±0.20	R

[Temperature Characteristic BJ : X5R] 1.5mm thickness (H)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMK325 BJ105MHHT		50	X5R	1 μ	±20	3.5	200	1.5±0.10	R
TMK325 BJ225MHHT		25	X5R	2.2 μ	±20	3.5	200	1.5±0.10	R

[Temperature Characteristic C6 : X6S] 2.5mm thickness (M)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
JMK325AC6107MMHT		6.3	X6S	100 μ	±20	10	150	2.5±0.30	R

[Temperature Characteristic B7 : X7R, C7 : X7S] 2.5mm thickness (M)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMK325 B7475□MHT		50	X7R	4.7 μ	±10, ±20	5	150	2.5±0.20	R
UMK325AB7106□MHT			X7R	10 μ	±10, ±20	10	150	2.5±0.30	R
UMK325AC7106MMHT			X7S	10 μ	±20	10	150	2.5±0.30	R
GMK325 C7106□MHT		35	X7S	10 μ	±10, ±20	5	150	2.5±0.20	R
TMK325AB7106□MHTR		25	X7R	10 μ	±10, ±20	10	150	2.5±0.30	R
TMK325 B7226□MHT			X7R	22 μ	±10, ±20	10	150	2.5±0.20	R
EMK325 B7226□MHT		16	X7R	22 μ	±10, ±20	10	150	2.5±0.20	R
LMK325 C7226MMHT		10	X7S	22 μ	±20	5	150	2.5±0.20	R
JMK325 B7226□MHTR		6.3	X7R	22 μ	±10, ±20	10	150	2.5±0.20	R
JMK325 B7476□MHTR			X7R	47 μ	±10, ±20	10	150	2.5±0.20	R

[Temperature Characteristic B7 : X7R] 1.9mm thickness (N)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
GMK325 B7225□NHT		35	X7R	2.2 μ	±10, ±20	3.5	200	1.9±0.20	R
GMK325 B7475MNHTR			X7R	4.7 μ	±20	10	150	1.9±0.20	R
TMK325 B7475□NHT		25	X7R	4.7 μ	±10, ±20	10	150	1.9±0.20	R
EMK325 B7106□NHT		16	X7R	10 μ	±10, ±20	5	150	1.9±0.20	R

[Temperature Characteristic B7 : X7R] 1.5mm thickness (H)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMK325 B7105□HHT		50	X7R	1 μ	±10, ±20	3.5	200	1.5±0.10	R

Multilayer Ceramic Capacitors (Temperature compensating type)

● 063TYPE (Dimension:0.6×0.3mm JIS:0603 EIA:0201)

[Temperature Characteristic CG : CG/C0G] 0.3mm thickness (T)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	Q	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMK063 CG0R5CTHF		50	CG C0G	0.5 p	± 0.25pF	410	200	0.3±0.03	R
UMK063 CG010CTHF			CG C0G	1 p	± 0.25pF	420	200	0.3±0.03	R
UMK063 CG1R5CTHF			CG C0G	1.5 p	± 0.25pF	430	200	0.3±0.03	R
UMK063 CG020CTHF			CG C0G	2 p	± 0.25pF	440	200	0.3±0.03	R
UMK063 CG030CTHF			CG C0G	3 p	± 0.25pF	460	200	0.3±0.03	R
UMK063 CG040CTHF			CG C0G	4 p	± 0.25pF	480	200	0.3±0.03	R
UMK063 CG050CTHF			CG C0G	5 p	± 0.25pF	500	200	0.3±0.03	R
UMK063 CG060DTHF			CG C0G	6 p	± 0.5pF	520	200	0.3±0.03	R
UMK063 CG070DTHF			CG C0G	7 p	± 0.5pF	540	200	0.3±0.03	R
UMK063 CG080DTHF			CG C0G	8 p	± 0.5pF	560	200	0.3±0.03	R
UMK063 CG090DTHF			CG C0G	9 p	± 0.5pF	580	200	0.3±0.03	R
UMK063 CG100DTHF			CG C0G	10 p	± 0.5pF	600	200	0.3±0.03	R
UMK063 CG120JTHF			CG C0G	12 p	± 5 %	640	200	0.3±0.03	R
UMK063 CG150JTHF			CG C0G	15 p	± 5 %	700	200	0.3±0.03	R
UMK063 CG180JTHF			CG C0G	18 p	± 5 %	760	200	0.3±0.03	R
UMK063 CG220JTHF			CG C0G	22 p	± 5 %	840	200	0.3±0.03	R
UMK063 CG270JTHF			CG C0G	27 p	± 5 %	940	200	0.3±0.03	R
UMK063 CG330JTHF			CG C0G	33 p	± 5 %	1000	200	0.3±0.03	R
UMK063 CG390JTHF			CG C0G	39 p	± 5 %	1000	200	0.3±0.03	R
UMK063 CG470JTHF			CG C0G	47 p	± 5 %	1000	200	0.3±0.03	R
UMK063 CG560JTHF			CG C0G	56 p	± 5 %	1000	200	0.3±0.03	R
UMK063 CG680JTHF			CG C0G	68 p	± 5 %	1000	200	0.3±0.03	R
UMK063 CG820JTHF			CG C0G	82 p	± 5 %	1000	200	0.3±0.03	R
UMK063 CG101JTHF			CG C0G	100 p	± 5 %	1000	200	0.3±0.03	R
TMK063 CG121JTHF		25	CG C0G	120 p	± 5 %	1000	200	0.3±0.03	R
TMK063 CG151JTHF			CG C0G	150 p	± 5 %	1000	200	0.3±0.03	R
TMK063 CG181JTHF			CG C0G	180 p	± 5 %	1000	200	0.3±0.03	R
TMK063 CG221JTHF			CG C0G	220 p	± 5 %	1000	200	0.3±0.03	R

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PART NUMBER

● 105TYPE (Dimension:1.0×0.5mm JIS:1005 EIA:0402)

[Temperature Characteristic CG : CG/C0G] 0.5mm thickness (V)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	Q	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMK105 CG0R5CVHF		50	CG C0G	0.5 p	±0.25pF	410	200	0.5±0.05	R
UMK105 CG010CVHF			CG C0G	1 p	±0.25pF	420	200	0.5±0.05	R
UMK105 CG1R5CVHF			CG C0G	1.5 p	±0.25pF	430	200	0.5±0.05	R
UMK105 CG020CVHF			CG C0G	2 p	±0.25pF	440	200	0.5±0.05	R
UMK105 CG030CVHF			CG C0G	3 p	±0.25pF	460	200	0.5±0.05	R
UMK105 CG040CVHF			CG C0G	4 p	±0.25pF	480	200	0.5±0.05	R
UMK105 CG050CVHF			CG C0G	5 p	±0.25pF	500	200	0.5±0.05	R
UMK105 CG060DVHF			CG C0G	6 p	±0.5pF	520	200	0.5±0.05	R
UMK105 CG070DVHF			CG C0G	7 p	±0.5pF	540	200	0.5±0.05	R
UMK105 CG080DVHF			CG C0G	8 p	±0.5pF	560	200	0.5±0.05	R
UMK105 CG090DVHF			CG C0G	9 p	±0.5pF	580	200	0.5±0.05	R
UMK105 CG100DVHF			CG C0G	10 p	±0.5pF	600	200	0.5±0.05	R
UMK105 CG120JVHF			CG C0G	12 p	±5%	640	200	0.5±0.05	R
UMK105 CG150JVHF			CG C0G	15 p	±5%	700	200	0.5±0.05	R
UMK105 CG180JVHF			CG C0G	18 p	±5%	760	200	0.5±0.05	R
UMK105 CG220JVHF			CG C0G	22 p	±5%	840	200	0.5±0.05	R
UMK105 CG270JVHF			CG C0G	27 p	±5%	940	200	0.5±0.05	R
UMK105 CG330JVHF			CG C0G	33 p	±5%	1000	200	0.5±0.05	R
UMK105 CG390JVHF			CG C0G	39 p	±5%	1000	200	0.5±0.05	R
UMK105 CG470JVHF			CG C0G	47 p	±5%	1000	200	0.5±0.05	R
UMK105 CG560JVHF			CG C0G	56 p	±5%	1000	200	0.5±0.05	R
UMK105 CG680JVHF			CG C0G	68 p	±5%	1000	200	0.5±0.05	R
UMK105 CG820JVHF			CG C0G	82 p	±5%	1000	200	0.5±0.05	R
UMK105 CG101JVHF			CG C0G	100 p	±5%	1000	200	0.5±0.05	R
UMK105 CG121JVHF			CG C0G	120 p	±5%	1000	200	0.5±0.05	R
UMK105 CG151JVHF			CG C0G	150 p	±5%	1000	200	0.5±0.05	R
UMK105 CG181JVHF			CG C0G	180 p	±5%	1000	200	0.5±0.05	R
UMK105 CG221JVHF			CG C0G	220 p	±5%	1000	200	0.5±0.05	R
UMK105 CG271JVHF			CG C0G	270 p	±5%	1000	200	0.5±0.05	R
UMK105 CG331JVHF			CG C0G	330 p	±5%	1000	200	0.5±0.05	R
UMK105 CG361JVHF			CG C0G	360 p	±5%	1000	200	0.5±0.05	R
UMK105 CG391JVHF			CG C0G	390 p	±5%	1000	200	0.5±0.05	R
UMK105 CG431JVHF			CG C0G	430 p	±5%	1000	200	0.5±0.05	R
UMK105 CG471JVHF			CG C0G	470 p	±5%	1000	200	0.5±0.05	R
UMK105 CG511JVHF			CG C0G	510 p	±5%	1000	200	0.5±0.05	R
UMK105 CG561JVHF			CG C0G	560 p	±5%	1000	200	0.5±0.05	R
UMK105 CG621JVHF			CG C0G	620 p	±5%	1000	200	0.5±0.05	R
UMK105 CG681JVHF			CG C0G	680 p	±5%	1000	200	0.5±0.05	R
UMK105 CG751JVHF			CG C0G	750 p	±5%	1000	200	0.5±0.05	R
UMK105 CG821JVHF			CG C0G	820 p	±5%	1000	200	0.5±0.05	R
UMK105 CG102JVHF			CG C0G	1000 p	±5%	1000	200	0.5±0.05	R

Medium-High Voltage Multilayer Ceramic Capacitors

● 107TYPE (Dimension:1.6×0.8mm JIS:1608 EIA:0603)

[Temperature Characteristic B7 : X7R] 0.8mm thickness (A)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
HMK107 B7102□AHT		100	X7R	1000 p	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7152□AHT			X7R	1500 p	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7222□AHT			X7R	2200 p	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7332□AHT			X7R	3300 p	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7472□AHT			X7R	4700 p	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7682□AHT			X7R	6800 p	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7103□AHT			X7R	0.01 μ	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7153□AHT			X7R	0.015 μ	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7223□AHT			X7R	0.022 μ	±10, ±20	3.5	200	0.8±0.10	R
HMK107 B7333□AHT			X7R	0.033 μ	±10, ±20	3.5	200	0.8±0.10	R

● 212TYPE (Dimension:2.0×1.25mm JIS:2012 EIA:0805)

[Temperature Characteristic B7 : X7R] 1.25mm thickness (G)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
HMK212 B7103□GHT		100	X7R	0.01 μ	±10, ±20	3.5	200	1.25±0.10	R
HMK212 B7153□GHT			X7R	0.015 μ	±10, ±20	3.5	200	1.25±0.10	R
HMK212 B7223□GHT			X7R	0.022 μ	±10, ±20	3.5	200	1.25±0.10	R
HMK212 B7333□GHT			X7R	0.033 μ	±10, ±20	3.5	200	1.25±0.10	R
HMK212 B7473□GHT			X7R	0.047 μ	±10, ±20	3.5	200	1.25±0.10	R
HMK212 B7683□GHT			X7R	0.068 μ	±10, ±20	3.5	200	1.25±0.10	R
HMK212 B7104□GHT			X7R	0.1 μ	±10, ±20	3.5	200	1.25±0.10	R
HMK212 B7224□GHT			X7R	0.22 μ	±10, ±20	3.5	200	1.25±0.10	R
QMK212 B7472□GHT		250	X7R	4700 p	±10, ±20	2.5	150	1.25±0.10	R
QMK212 B7682□GHT			X7R	6800 p	±10, ±20	2.5	150	1.25±0.10	R
QMK212 B7103□GHT			X7R	0.01 μ	±10, ±20	2.5	150	1.25±0.10	R
QMK212 B7153□GHT			X7R	0.015 μ	±10, ±20	2.5	150	1.25±0.10	R
QMK212 B7223□GHT			X7R	0.022 μ	±10, ±20	2.5	150	1.25±0.10	R

[Temperature Characteristic B7 : X7R] 0.85mm thickness (D)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
QMK212 B7102□DHT		250	X7R	1000 p	±10, ±20	2.5	150	0.85±0.10	R
QMK212 B7152□DHT			X7R	1500 p	±10, ±20	2.5	150	0.85±0.10	R
QMK212 B7222□DHT			X7R	2200 p	±10, ±20	2.5	150	0.85±0.10	R
QMK212 B7332□DHT			X7R	3300 p	±10, ±20	2.5	150	0.85±0.10	R

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PART NUMBER

● 316TYPE (Dimension:3.2×1.6mm JIS:3216 EIA:1206)

[Temperature Characteristic B7 : X7R] 1.6mm thickness (L)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
HMK316 B7473□LHT		100	X7R	0.047 μ	±10, ±20	3.5	200	1.6±0.20	R
HMK316 B7104□LHT			X7R	0.1 μ	±10, ±20	3.5	200	1.6±0.20	R
HMK316 B7154□LHT			X7R	0.15 μ	±10, ±20	3.5	200	1.6±0.20	R
HMK316 B7224□LHT			X7R	0.22 μ	±10, ±20	3.5	200	1.6±0.20	R
HMK316 B7334□LHT			X7R	0.33 μ	±10, ±20	3.5	200	1.6±0.20	R
HMK316 B7474□LHT			X7R	0.47 μ	±10, ±20	3.5	200	1.6±0.20	R
HMK316 B7105□LHT			X7R	1 μ	±10, ±20	3.5	200	1.6±0.20	R
QMK316 B7333□LHT		250	X7R	0.033 μ	±10, ±20	2.5	150	1.6±0.20	R
QMK316 B7473□LHT			X7R	0.047 μ	±10, ±20	2.5	150	1.6±0.20	R
QMK316 B7683□LHT			X7R	0.068 μ	±10, ±20	2.5	150	1.6±0.20	R
QMK316 B7104□LHT			X7R	0.1 μ	±10, ±20	2.5	150	1.6±0.20	R
SMK316 B7153□LHT		630	X7R	0.015 μ	±10, ±20	2.5	120	1.6±0.20	R
SMK316 B7223□LHT			X7R	0.022 μ	±10, ±20	2.5	120	1.6±0.20	R

[Temperature Characteristic B7 : X7R] 1.15mm thickness (F)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
SMK316 B7102□FHT		630	X7R	1000 p	±10, ±20	2.5	120	1.15±0.10	R
SMK316 B7152□FHT			X7R	1500 p	±10, ±20	2.5	120	1.15±0.10	R
SMK316 B7222□FHT			X7R	2200 p	±10, ±20	2.5	120	1.15±0.10	R
SMK316 B7332□FHT			X7R	3300 p	±10, ±20	2.5	120	1.15±0.10	R
SMK316 B7472□FHT			X7R	4700 p	±10, ±20	2.5	120	1.15±0.10	R
SMK316 B7682□FHT			X7R	6800 p	±10, ±20	2.5	120	1.15±0.10	R
SMK316 B7103□FHT			X7R	0.01 μ	±10, ±20	2.5	120	1.15±0.10	R

● 325TYPE (Dimension:3.2×2.5mm JIS:3225 EIA:1210)

[Temperature Characteristic B7 : X7R] 2.5mm thickness (M)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
HMK325 B7225□MHT		100	X7R	2.2 μ	±10, ±20	3.5	200	2.5±0.20	R

[Temperature Characteristic B7 : X7R] 1.9mm thickness (N)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
HMK325 B7224□NHT		100	X7R	0.22 μ	±10, ±20	3.5	200	1.9±0.20	R
HMK325 B7474□NHT			X7R	0.47 μ	±10, ±20	3.5	200	1.9±0.20	R
HMK325 B7684□NHT			X7R	0.68 μ	±10, ±20	3.5	200	1.9±0.20	R
HMK325 B7105□NHT			X7R	1 μ	±10, ±20	3.5	200	1.9±0.20	R
QMK325 B7473□NHT		250	X7R	0.047 μ	±10, ±20	2.5	150	1.9±0.20	R
QMK325 B7104□NHT			X7R	0.1 μ	±10, ±20	2.5	150	1.9±0.20	R
QMK325 B7154□NHT			X7R	0.15 μ	±10, ±20	2.5	150	1.9±0.20	R
QMK325 B7224□NHT			X7R	0.22 μ	±10, ±20	2.5	150	1.9±0.20	R
SMK325 B7223□NHT		630	X7R	0.022 μ	±10, ±20	2.5	120	1.9±0.20	R
SMK325 B7333□NHT			X7R	0.033 μ	±10, ±20	2.5	120	1.9±0.20	R
SMK325 B7473□NHT			X7R	0.047 μ	±10, ±20	2.5	120	1.9±0.20	R

[Temperature Characteristic B7 : X7R] 1.15mm thickness (F)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
HMK325 B7104□FHT		100	X7R	0.1 μ	±10, ±20	3.5	200	1.15±0.10	R

● 432TYPE (Dimension:4.5×3.2mm JIS:4532 EIA:1812)

[Temperature Characteristic B7 : X7R] 2.5mm thickness (M)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
HMK432 B7474□MHT		100	X7R	0.47 μ	±10, ±20	3.5	200	2.5±0.20	R
HMK432 B7105□MHT			X7R	1 μ	±10, ±20	3.5	200	2.5±0.20	R
HMK432 B7155□MHT			X7R	1.5 μ	±10, ±20	3.5	200	2.5±0.20	R
HMK432 B7225□MHT			X7R	2.2 μ	±10, ±20	3.5	200	2.5±0.20	R
QMK432 B7104□MHT		250	X7R	0.1 μ	±10, ±20	2.5	150	2.5±0.20	R
QMK432 B7224□MHT			X7R	0.22 μ	±10, ±20	2.5	150	2.5±0.20	R
QMK432 B7334□MHT			X7R	0.33 μ	±10, ±20	2.5	150	2.5±0.20	R
QMK432 B7474□MHT			X7R	0.47 μ	±10, ±20	2.5	150	2.5±0.20	R
SMK432 B7473□MHT		630	X7R	0.047 μ	±10, ±20	2.5	120	2.5±0.20	R
SMK432 B7683□MHT			X7R	0.068 μ	±10, ±20	2.5	120	2.5±0.20	R
SMK432 B7104□MHT			X7R	0.1 μ	±10, ±20	2.5	120	2.5±0.20	R

Soft Termination Multilayer Ceramic Capacitors

● 212TYPE (Dimension:2.0×1.25mm JIS:2012 EIA:0805)

[Temperature Characteristic B7 : X7R] 0.85mm thickness (D)、1.25mm thickness (G)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMJ212BB7103□GHT		50	X7R	0.01 μ	±10, ±20	2.5	200	1.25±0.20/-0	R
UMJ212BB7223□GHT			X7R	0.022 μ	±10, ±20	3.5	200	1.25±0.20/-0	R
UMJ212BB7473□GHT			X7R	0.047 μ	±10, ±20	3.5	200	1.25±0.20/-0	R
HMJ212KB7102□DHT			X7R	1000 p	±10, ±20	2.5	200	0.85±0.15	R
HMJ212KB7222□DHT		100	X7R	2200 p	±10, ±20	2.5	200	0.85±0.15	R
HMJ212BB7472□GHT			X7R	4700 p	±10, ±20	2.5	200	1.25±0.20/-0	R
HMJ212BB7103□GHT			X7R	0.01 μ	±10, ±20	2.5	200	1.25±0.20/-0	R
HMJ212BB7223□GHT			X7R	0.022 μ	±10, ±20	3.5	200	1.25±0.20/-0	R
HMJ212BB7473□GHT			X7R	0.047 μ	±10, ±20	3.5	200	1.25±0.20/-0	R
HMJ212BB7104□GHT			X7R	0.1 μ	±10, ±20	3.5	200	1.25±0.20/-0	R
HMJ212BB7224□GHT			X7R	0.22 μ	±10, ±20	3.5	200	1.25±0.20/-0	R
QMJ212KB7102□DHT			X7R	1000 p	±10, ±20	2.5	150	0.85±0.15	R
QMJ212KB7222□DHT		250	X7R	2200 p	±10, ±20	2.5	150	0.85±0.15	R
QMJ212BB7472□GHT			X7R	4700 p	±10, ±20	2.5	150	1.25±0.20/-0	R
QMJ212BB7103□GHT			X7R	0.01 μ	±10, ±20	2.5	150	1.25±0.20/-0	R

► This catalog contains the typical specification only due to the limitation of space. When you consider the purchase of our products, please check our specification. For details of each product (characteristics graph, reliability information, precautions for use, and so on), see our Web site (<http://www.ty-top.com/>).

PART NUMBER

● 316TYPE (Dimension:3.2×1.6mm JIS:3216 EIA:1206)

[Temperature Characteristic B7 : X7R] 1.15mm thickness (F) 、 1.6mm thickness (L)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
LMJ316BB7226[LHT]		10	X7R	22 μ	±10, ±20	10	150	1.6±0.30	R
EMJ316BB7475[LHT]		16	X7R	4.7 μ	±10, ±20	10	150	1.6±0.30	R
EMJ316BB7106[LHT]			X7R	10 μ	±10, ±20	10	150	1.6±0.30	R
TMJ316AB7474[LHT]			X7R	0.47 μ	±10, ±20	3.5	200	1.6±0.20	R
TMJ316BB7475[LHT]		25	X7R	4.7 μ	±10, ±20	10	150	1.6±0.30	R
TMJ316BB7106[LHT]			X7R	10 μ	±10, ±20	10	150	1.6±0.30	R
GMJ316AB7474[LHT]			X7R	0.47 μ	±10, ±20	3.5	200	1.6±0.20	R
GMJ316AB7225[LHT]		35	X7R	2.2 μ	±10, ±20	10	150	1.6±0.20	R
GMJ316BB7475[LHT]			X7R	4.7 μ	±10, ±20	10	150	1.6±0.30	R
GMJ316BB7106[LHT]			X7R	10 μ	±10, ±20	10	150	1.6±0.30	R
UMJ316BB7473[LHT]			X7R	0.047 μ	±10, ±20	2.5	200	1.6±0.30	R
UMJ316BB7104[LHT]			X7R	0.1 μ	±10, ±20	3.5	200	1.6±0.30	R
UMJ316BB7224[LHT]		50	X7R	0.22 μ	±10, ±20	3.5	200	1.6±0.30	R
UMJ316AB7474[LHT]			X7R	0.47 μ	±10, ±20	3.5	200	1.6±0.20	R
UMJ316BB7105[LHT]			X7R	1 μ	±10, ±20	3.5	200	1.6±0.30	R
UMJ316AB7225[LHT]			X7R	2.2 μ	±10, ±20	10	150	1.6±0.20	R
HMJ316 B7102[FHT]			X7R	1000 p	±10, ±20	2.5	200	1.15±0.10	R
HMJ316 B7222[FHT]			X7R	2200 p	±10, ±20	2.5	200	1.15±0.10	R
HMJ316 B7472[FHT]			X7R	4700 p	±10, ±20	2.5	200	1.15±0.10	R
HMJ316BB7223[LHT]		100	X7R	0.022 μ	±10, ±20	2.5	200	1.6±0.30	R
HMJ316BB7473[LHT]			X7R	0.047 μ	±10, ±20	2.5	200	1.6±0.30	R
HMJ316BB7104[LHT]			X7R	0.1 μ	±10, ±20	2.5	200	1.6±0.30	R
HMJ316BB7224[LHT]			X7R	0.22 μ	±10, ±20	3.5	200	1.6±0.30	R
HMJ316BB7474[LHT]			X7R	0.47 μ	±10, ±20	3.5	200	1.6±0.30	R
HMJ316BB7105[LHT]			X7R	1 μ	±10, ±20	3.5	200	1.6±0.30	R
QMJ316 B7102[FHT]			X7R	1000 p	±10, ±20	2.5	150	1.15±0.10	R
QMJ316 B7222[FHT]			X7R	2200 p	±10, ±20	2.5	150	1.15±0.10	R
QMJ316 B7472[FHT]		250	X7R	4700 p	±10, ±20	2.5	150	1.15±0.10	R
QMJ316BB7223[LHT]			X7R	0.022 μ	±10, ±20	2.5	150	1.6±0.30	R
QMJ316BB7473[LHT]			X7R	0.047 μ	±10, ±20	2.5	150	1.6±0.30	R
QMJ316BB7104[LHT]			X7R	0.1 μ	±10, ±20	2.5	150	1.6±0.30	R
SMJ316 B7102[FHT]		630	X7R	1000 p	±10, ±20	2.5	120	1.15±0.10	R
SMJ316 B7222[FHT]			X7R	2200 p	±10, ±20	2.5	120	1.15±0.10	R
SMJ316 B7472[FHT]			X7R	4700 p	±10, ±20	2.5	120	1.15±0.10	R

● 325TYPE (Dimension:3.2×2.5mm JIS:3225 EIA:1210)

[Temperature Characteristic B7 : X7R] 1.9mm thickness (N) 、 2.5mm thickness (M)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
JMJ325KB7476[MHT]		6.3	X7R	47 μ	±10, ±20	10	150	2.5±0.30	R
EMJ325KB7226[MHT]		16	X7R	22 μ	±10, ±20	10	150	2.5±0.30	R
TMJ325AB7475[MHT]		25	X7R	4.7 μ	±10, ±20	5	150	2.5±0.30	R
TMJ325KB7106[MHT]			X7R	10 μ	±10, ±20	10	150	2.5±0.30	R
GMJ325AB7475[MHT]		35	X7R	4.7 μ	±10, ±20	5	150	2.5±0.30	R
GMJ325KB7106[MHT]			X7R	10 μ	±10, ±20	10	150	2.5±0.30	R
UMJ325AB7225[MHT]		50	X7R	2.2 μ	±10, ±20	3.5	200	2.5±0.30	R
UMJ325AB7475[MHT]			X7R	4.7 μ	±10, ±20	5	150	2.5±0.30	R
UMJ325KB7106[MHT]			X7R	10 μ	±10, ±20	10	150	2.5±0.30	R
HMJ325 B7223[NHT]			X7R	0.022 μ	±10, ±20	2.5	200	1.9±0.20	R
HMJ325 B7473[NHT]			X7R	0.047 μ	±10, ±20	2.5	200	1.9±0.20	R
HMJ325 B7104[NHT]		100	X7R	0.1 μ	±10, ±20	2.5	200	1.9±0.20	R
HMJ325 B7224[NHT]			X7R	0.22 μ	±10, ±20	2.5	200	1.9±0.20	R
HMJ325 B7474[NHT]			X7R	0.47 μ	±10, ±20	3.5	200	1.9±0.20	R
HMJ325 B7105[NHT]			X7R	1 μ	±10, ±20	3.5	200	1.9±0.20	R
HMJ325AB7225[MHT]			X7R	2.2 μ	±10, ±20	3.5	200	2.5±0.30	R
QMJ325 B7223[NHT]		250	X7R	0.022 μ	±10, ±20	2.5	150	1.9±0.20	R
QMJ325 B7473[NHT]			X7R	0.047 μ	±10, ±20	2.5	150	1.9±0.20	R
QMJ325 B7104[NHT]			X7R	0.1 μ	±10, ±20	2.5	150	1.9±0.20	R
QMJ325 B7224[NHT]			X7R	0.22 μ	±10, ±20	2.5	150	1.9±0.20	R
SMJ325 B7223[NHT]		630	X7R	0.022 μ	±10, ±20	2.5	120	1.9±0.20	R
SMJ325 B7473[NHT]			X7R	0.047 μ	±10, ±20	2.5	120	1.9±0.20	R

LW Reversal Decoupling Capacitors (LWDC™)

● 105TYPE (Dimension:0.52×1.0mm JIS:0510 EIA:0204)

[Temperature Characteristic BJ : X5R] 0.3mm thickness (P)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
TWK105 BJ104MPHF		25	X5R	0.1 μ	±20	5	150	0.3±0.05	R
EWK105 BJ224MPHF		16	X5R	0.22 μ	±20	10	150	0.3±0.05	R
LWK105 BJ474MPHF		10	X5R	0.47 μ	±20	10	150	0.3±0.05	R
AWK105 BJ105MPHF		4	X5R	1 μ	±20	10	150	0.3±0.05	R

[Temperature Characteristic C6 : X6S , C7 : X7S] 0.3mm thickness (P)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
EWK105 C6104MPHF		16	X6S	0.1 μ	±20	5	150	0.3±0.05	R
LWK105 C7104MPHF		10	X7S	0.1 μ	±20	5	150	0.3±0.05	R
LWK105 C6224MPHF			X6S	0.22 μ	±20	10	150	0.3±0.05	R
JWK105 C7104MPHF			X7S	0.1 μ	±20	5	150	0.3±0.05	R
JWK105 C7224MPHF		6.3	X7S	0.22 μ	±20	10	150	0.3±0.05	R
JWK105 C6474MPHF			X6S	0.47 μ	±20	10	150	0.3±0.05	R
AWK105 C7224MPHF		4	X7S	0.22 μ	±20	10	150	0.3±0.05	R
AWK105 C6474MPHF			X6S	0.47 μ	±20	10	150	0.3±0.05	R

PART NUMBER

● 107TYPE (Dimension:0.8×1.6mm JIS:0816 EIA:0306)

[Temperature Characteristic BJ : X5R] 0.5mm thickness (V)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
LWK107 BJ105MVHT		10	X5R	1 μ	±20	10	150	0.5±0.05	R
JWK107 BJ225MVHT		6.3	X5R	2.2 μ	±20	10	150	0.5±0.05	R
JWK107 BJ475MVHT			X5R	4.7 μ	±20	10	150	0.5±0.05	R

[Temperature Characteristic B7 : X7R , C6 : X6S , C7 : X7S] 0.5mm thickness (V)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
TWK107 B7104MVHT		25	X7R	0.1 μ	±20	5	150	0.5±0.05	R
EWK107 B7224MVHT		16	X7R	0.22 μ	±20	5	150	0.5±0.05	R
EWK107 B7474MVHT			X7R	0.47 μ	±20	5	150	0.5±0.05	R
LWK107 B7474MVHT		10	X7R	0.47 μ	±20	5	150	0.5±0.05	R
JWK107 C7105MVHT		6.3	X7S	1 μ	±20	10	150	0.5±0.05	R
AWK107 C6225MVHT		4	X6S	2.2 μ	±20	10	150	0.5±0.05	R
AWK107 C6475MVHT			X6S	4.7 μ	±20	10	150	0.5±0.05	R

● 212TYPE (Dimension:1.25×2.0mm JIS:1220 EIA:0508)

[Temperature Characteristic BJ : X5R] 0.85mm thickness (D)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
LWK212 BJ475□DHT		10	X5R	4.7 μ	±10, ±20	10	150	0.85±0.10	R
JWK212 BJ106MDHT		6.3	X5R	10 μ	±20	10	150	0.85±0.10	R
AWK212 BJ226MDHT		4	X5R	22 μ	±20	10	150	0.85±0.10	R

[Temperature Characteristic C6 : X6S] 0.85mm thickness (D)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
JWK212 C6475□DHT		6.3	X6S	4.7 μ	±10, ±20	10	150	0.85±0.10	R

PART NUMBER

High Reliability Application Multilayer Ceramic Capacitors

● 107TYPE (Dimension:1.6×0.8mm JIS:1608 EIA:0603)

[Temperature Characteristic B7 : X7R] 0.8mm thickness (A)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMR107 B7104□A-T		50	X7R	0.1 μ	±10, ±20	3.5	200	0.8±0.10	R
TMR107 B7224□A-T		25	X7R	0.22 μ	±10, ±20	3.5	200	0.8±0.10	R
EMR107 B7474□A-T		16	X7R	0.47 μ	±10, ±20	3.5	200	0.8±0.10	R
LMR107 B7105□A-T		10	X7R	1 μ	±10, ±20	5	200	0.8±0.10	R

● 212TYPE (Dimension:2.0×1.25mm JIS:2012 EIA:0805)

[Temperature Characteristic B7 : X7R] 1.25mm thickness (G)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMR212 B7473□G-T		50	X7R	0.047 μ	±10, ±20	3.5	200	1.25±0.10	R
UMR212 B7104□G-T			X7R	0.1 μ	±10, ±20	3.5	200	1.25±0.10	R
UMR212 B7224□G-T			X7R	0.22 μ	±10, ±20	3.5	200	1.25±0.10	R
TMR212 B7474□G-T		25	X7R	0.47 μ	±10, ±20	3.5	200	1.25±0.10	R
TMR212 B7105□G-T			X7R	1 μ	±10, ±20	5	200	1.25±0.10	R
LMR212 B7225□G-T		10	X7R	2.2 μ	±10, ±20	5	200	1.25±0.10	R

● 316TYPE (Dimension:3.2×1.6mm JIS:3216 EIA:1206)

[Temperature Characteristic B7 : X7R] 1.6mm thickness (L)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMR316 B7224□L-T		50	X7R	0.22 μ	±10, ±20	3.5	200	1.6±0.20	R
TMR316 B7474□L-T		25	X7R	0.47 μ	±10, ±20	3.5	200	1.6±0.20	R
TMR316 B7105□L-T			X7R	1 μ	±10, ±20	3.5	200	1.6±0.20	R
EMR316 B7225□L-T		16	X7R	2.2 μ	±10, ±20	3.5	200	1.6±0.20	R
LMR316 B7475□L-T		10	X7R	4.7 μ	±10, ±20	5	200	1.6±0.20	R
JMR316 B7106□L-T		6.3	X7R	10 μ	±10, ±20	5	200	1.6±0.20	R

● 325TYPE (Dimension:3.2×2.5mm JIS:3225 EIA:1210)

[Temperature Characteristic B7 : X7R] 2.5mm thickness (M)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
TMR325 B7106□M-T		25	X7R	10 μ	±10, ±20	5	200	2.5±0.20	R

[Temperature Characteristic B7 : X7R] 1.9mm thickness (N)

Part number 1	Part number 2	Rated voltage [V]	Temperature characteristics	Capacitance [F]	Capacitance tolerance [%]	tan δ [%]	HALT	Thickness*1 [mm]	Soldering R:Reflow W:Wave
							Rated voltage x %		
UMR325 B7474□N-T		50	X7R	0.47 μ	±10, ±20	3.5	200	1.9±0.20	R
UMR325 B7105□N-T			X7R	1 μ	±10, ±20	3.5	200	1.9±0.20	R
TMR325 B7225□N-T		25	X7R	2.2 μ	±10, ±20	3.5	200	1.9±0.20	R
TMR325 B7475□N-T			X7R	4.7 μ	±10, ±20	3.5	200	1.9±0.20	R

Multilayer Ceramic Capacitors

PACKAGING

① Minimum Quantity

Taped package

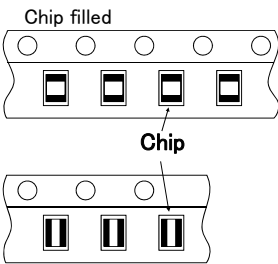
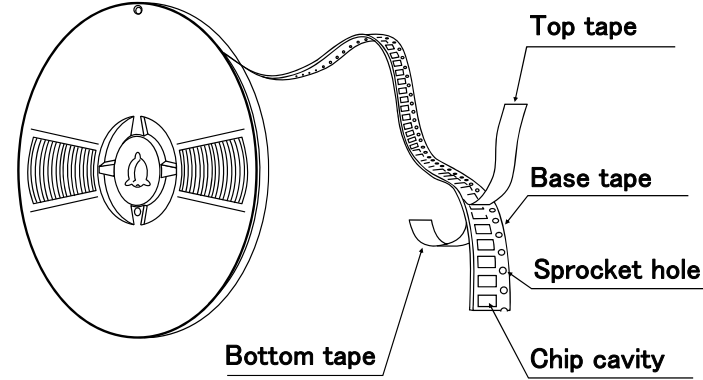
Type(EIA)	Thickness		Standard quantity [pcs]		
	mm	code	Paper tape	Embossed tape	
□MK042(01005)	0.2	C, D	—	40000	
□VS042(01005)	0.2	C			
□MK063(0201)	0.3	P, T	15000	—	
□WK105(0204) ※	0.3	P	10000		
□MK105(0402)	0.2	C	20000		
	0.3	P	15000		
	0.5	V	10000		
□VK105(0402) ※	0.5	W			
□MK107(0603)	0.45	K	4000	4000	
□WK107(0306) ※	0.5	V	—		
□MR107(0603)	0.8	A	4000		
□MK212(0805)	0.45	K		—	3000
□WK212(0508) ※	0.85	D			
□MR212(0805)	125	G			
□MK316(1206) □MR316(1206)	0.85	D	4000	—	
	1.15	F	—	3000	
	125	G			
		1.6	L	—	2000
□MK325(1210) □MR325(1210)	0.85	D	—	2000	
	1.15	F			
	1.9	N			
	2.0max.	Y			
		2.5	M		500(T), 1000(P)
□MK432(1812)	2.5	M	—	500	

Note : ※ LW Reverse type.

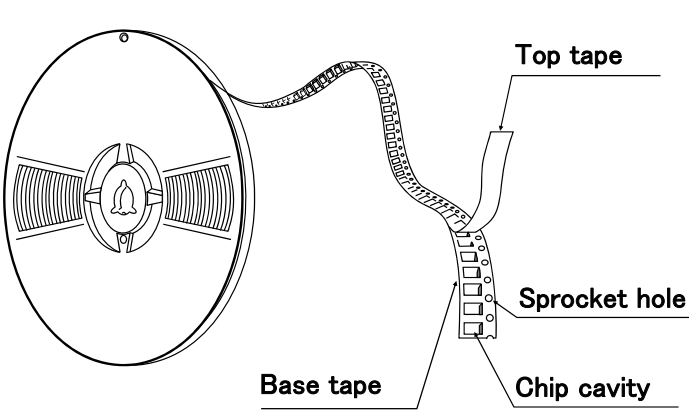
② Taping material

※No bottom tape for pressed carrier tape

Card board carrier tape



Embossed tape

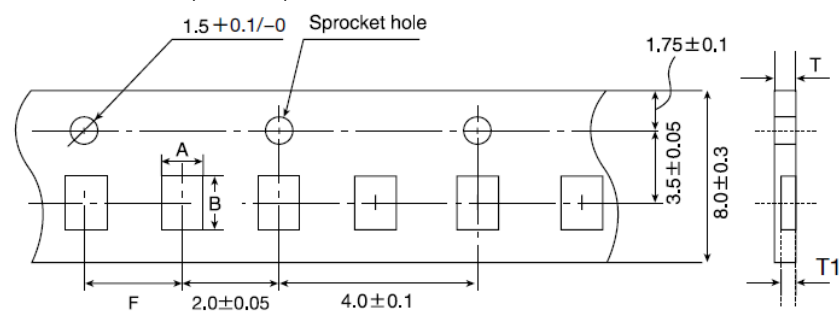


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③ Representative taping dimensions

● Paper Tape (8mm wide)

● Pressed carrier tape (2mm pitch)



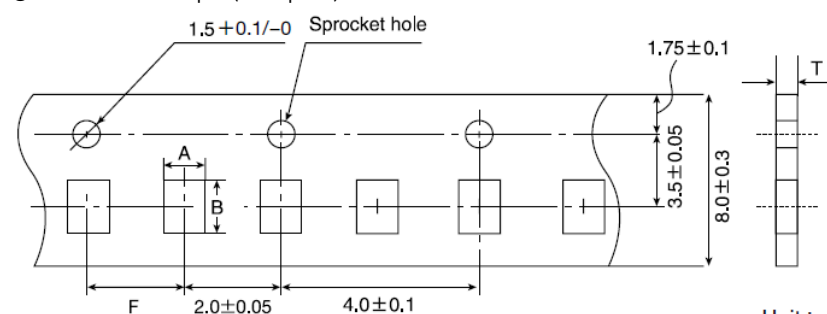
Unit : mm

Type(EIA)	Chip Cavity		Unit : mm Insertion Pitch	Tape Thickness	
	A	B	F	T	T1
□MK063(0201)	0.37	0.67	2.0±0.05	0.45max.	0.42max.
□WK105(0204) ※	0.65	1.15		0.4max.	0.3max.
□MK105(0402) (*1 C)				0.45max.	0.42max.
□MK105(0402) (*1 P)					

Note *1 Thickness, C: 0.2mm ,P: 0.3mm. ※ LW Reverse type.

Unit : mm

● Punched carrier tape (2mm pitch)

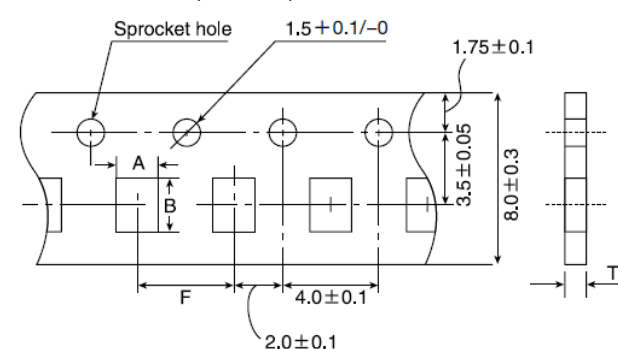


Unit : mm

Type(EIA)	Chip Cavity		Insertion Pitch	Tape Thickness
	A	B	F	T
□MK105 (0402)	0.65	1.15	2.0±0.05	0.8max.
□VK105 (0402)				

Unit : mm

● Punched carrier tape (4mm pitch)



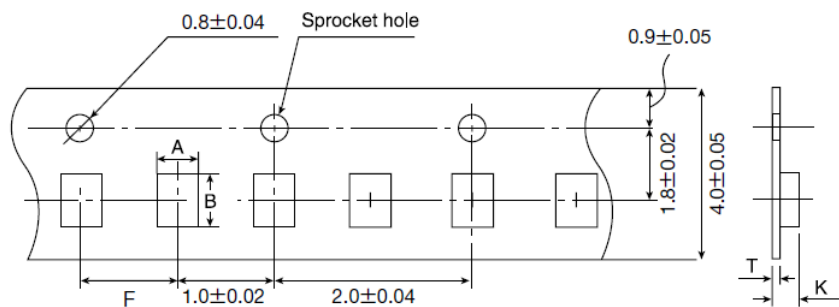
Unit : mm

Type(EIA)	Chip Cavity		Insertion Pitch	Tape Thickness
	A	B	F	T
□MK107(0603) □WK107(0306) ※ □MR107(0603)	1.0	1.8	4.0±0.1	1.1max.
□MK212(0805) □WK212(0508) ※				2.4
□MK316(1206)	2.0	3.6		

Note : Taping size might be different depending on the size of the product. ※ LW Reverse type.

Unit : mm

● Embossed tape (4mm wide)

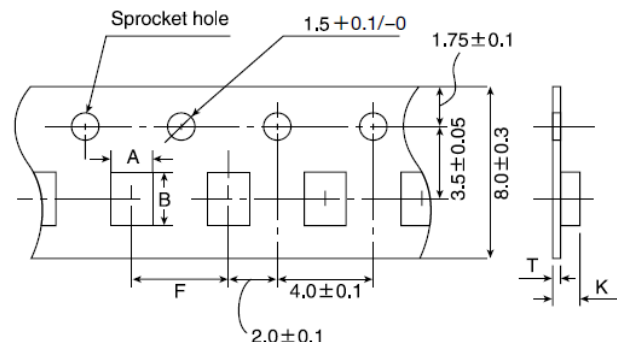


Unit : mm

Type(EIA)	Chip Cavity		Insertion Pitch	Tape Thickness	
	A	B	F	K	T
□MK042(01005)	0.23	0.43	1.0±0.02	0.5max.	0.25max.
□VS042(01005)					

Unit : mm

● Embossed tape (8mm wide)



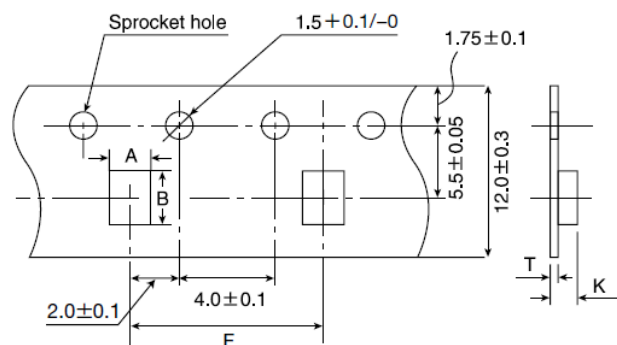
Unit : mm

Type(EIA)	Chip Cavity		Insertion Pitch	Tape Thickness	
	A	B	F	K	T
□WK107(0306) ※	1.0	1.8	4.0±0.1	1.3max.	0.25±0.1
□MK212(0805)	1.65	2.4		3.4max.	0.6max.
□MR212(0805)					
□MK316(1206)	2.0	3.6			
□MR316(1206)					
□MK325(1210)	2.8	3.6			
□MR325(1210)					

Note: ※ LW Reverse type.

Unit : mm

● Embossed tape (12mm wide)

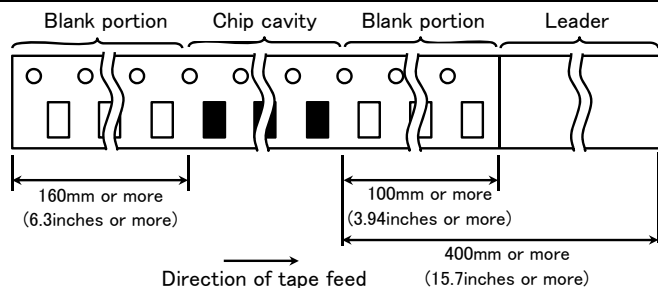


Unit : mm

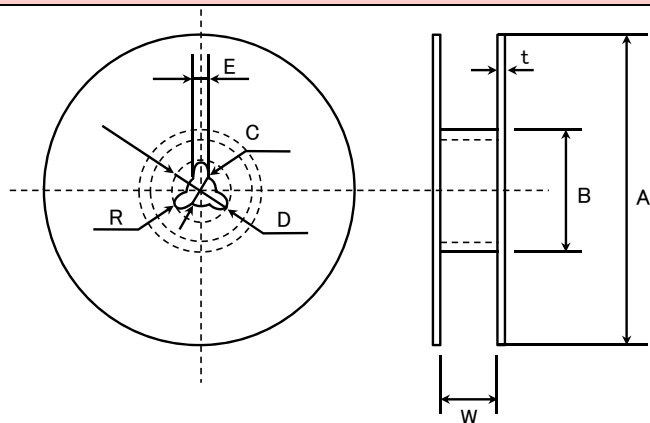
Type(EIA)	Chip Cavity		Insertion Pitch	Tape Thickness	
	A	B	F	K	T
□MK432(1812)	3.7	4.9	8.0±0.1	4.0max.	0.6max.

Unit : mm

④Trailer and Leader



⑤Reel size



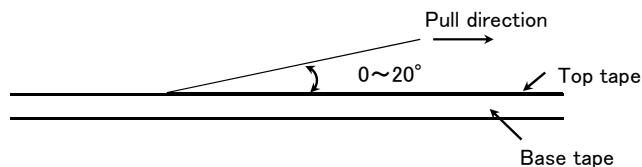
A	B	C	D	E	R
$\phi 178 \pm 2.0$	$\phi 50 \text{ min.}$	$\phi 13.0 \pm 0.2$	$\phi 21.0 \pm 0.8$	2.0 ± 0.5	1.0

	T	W
4mm wide tape	1.5max.	5 ± 1.0
8mm wide tape	2.5max.	10 ± 1.5
12mm wide tape	2.5max.	14 ± 1.5

Unit: mm

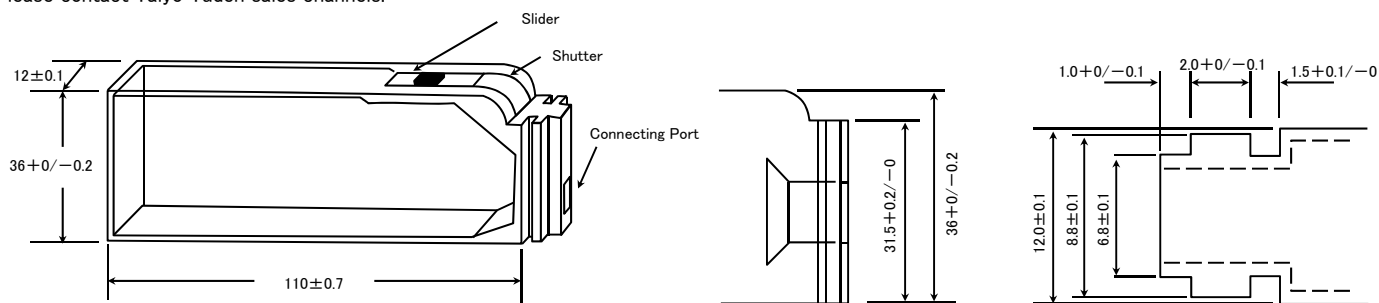
⑥Top Tape Strength

The top tape requires a peel-off force of 0.1 to 0.7N in the direction of the arrow as illustrated below.



⑦Bulk Cassette

The exchange of individual specification is necessary.
Please contact Taiyo Yuden sales channels.



Unit: mm

Multilayer Ceramic Capacitors

RELIABILITY DATA

1. Operating Temperature Range

Specified Value	Temperature Compensating (Class1)	Standard	−55 to +125℃		
		High Frequency Type			
	High Permittivity (Class2)				
		BJ	Specification	Temperature Range	
			B	−25 to +85℃	
		X5R	−55 to +85℃		
		B7	X7R	−55 to +125℃	
		C6	X6S	−55 to +105℃	
		C7	X7S	−55 to +125℃	
		LD(※)	X5R	−55 to +85℃	
F	F	−25 to +85℃			
	Y5V	−30 to +85℃			
Note: ※LD Low distortion high value multilayer ceramic capacitor					

2. Storage Conditions

Specified Value	Temperature Compensating (Class1)	Standard	−55 to +125°C		
		High Frequency Type			
	High Permittivity (Class2)		Specification	Temperature Range	
		BJ	B	−25 to +85°C	
			X5R	−55 to +85°C	
		B7	X7R	−55 to +125°C	
		C6	X6S	−55 to +105°C	
		C7	X7S	−55 to +125°C	
		LD(※)	X5R	−55 to +85°C	
		F	F	−25 to +85°C	
Y5V	−30 to +85°C				
Note: ※LD Low distortion high value multilayer ceramic capacitor					

3. Rated Voltage

Specified Value	Temperature Compensating (Class1)	Standard	50VDC, 25VDC, 16VDC
		High Frequency Type	50VDC, 16VDC
	High Permittivity (Class2)		50VDC, 35VDC, 25VDC, 16VDC, 10VDC, 6.3VDC, 4VDC, 2.5VDC

4. Withstanding Voltage (Between terminals)

Specified Value	Temperature Compensating (Class1)	Standard	No breakdown or damage
		High Frequency Type	
Test Methods and Remarks	High Permittivity (Class2)		
	Class 1		Class 2
	Applied voltage		Rated volta × 3 Rated voltage × 2.5
	Duration		1 to 5 sec.
Test Methods and Remarks	Charge/discharge current		50mA max.

5. Insulation Resistance

Specified Value	Temperature Compensating (Class1)	Standard	10000 MΩ min.
		High Frequency Type	
Specified Value	High Permittivity (Class2) Note 1		C ≤ 0.047 μF : 10000 MΩ min. C > 0.047 μF : 500MΩ · μF
Test Methods and Remarks	Applied voltage		: Rated voltage
	Duration		: 60 ± 5 sec.
	Charge/discharge current		: 50mA max.

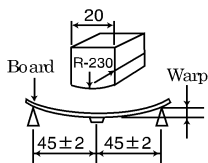
6. Capacitance (Tolerance)							
Specified Value	Temperature Compensating(Class1)	Standard	C□	0.2pF≦C≦5pF : ±0.25pF			
			U□	0.2pF≦C≦10pF : ±0.5pF			
		SL	C>10pF : ±5% or ±10%				
	High Frequency Type	CH	0.3pF≦C≦2pF : ±0.1pF				
		RH	C>2pF : ±5%				
High Permittivity (Class2)			BJ, B7, C6, C7, LD(※) : ±10% or ±20%, F : +80/−20% Note: ※LD Low distortion high value multilayer ceramic capacitor				
Test Methods and Remarks		Class 1		Class 2			
		Standard	High Frequency Type	C≦10μF	C>10μF		
	Preconditioning	None		Thermal treatment (at 150℃ for 1hr) Note 2			
	Measuring frequency	1MHz±10%		1kHz±10%	120±10Hz		
	Measuring voltage Note	0.5 to 5Vrms		1±0.2Vrms	0.5±0.1rms		
	Bias application	one					
7. Q or Dissipation Factor							
Specified Value	Temperature Compensating(Class1)	Standard	C<30pF : Q≧400+20C C≧30pF : Q≧1000 (C:Nominal capacitance)				
		High Frequency Type	Refer to detailed specification				
	High Permittivity (Class2) Note 1		BJ, B7, C6, C7:2.5% max., F:7% max.				
Test Methods and Remarks		Class 1		Class 2			
		Standard	High Frequency Type	C≦10μF	C>10μF		
	Preconditioning	None		Thermal treatment (at 150℃ for 1hr) Note 2			
	Measuring frequency	1MHz±10%	1GHz	1kHz±10%	120±10Hz		
	Measuring voltage Note 1	0.5 to 5Vrms		1±0.2Vrms	0.5±0.1Vrms		
	Bias application	None					
High Frequency Type							
Measuring equipment		: HP4291A					
Measuring jig		: HP16192A					
8. Temperature Characteristic (Without voltage application)							
Specified Value	Temperature Compensating(Class1)	Standard	Temperature Characteristic [ppm/℃]		Tolerance [ppm/℃]		
			C□ : 0	CG,CH, CJ, CK	G : ±30 H : ±60		
			U□ : −750	UJ, UK	J : ±120 K : ±250		
			SL : +350 to −1000				
	High Permittivity (Class2)	High Frequency Type	Temperature Characteristic [ppm/℃]		Tolerance [ppm/℃]		
			C□ : 0	CH	H : ±60		
			R□ : −220	RH			
	Test Methods and Remarks	High Permittivity (Class2)		Specification	Capacitance change	Reference temperature	Temperature Range
			BJ	B	±10%	20℃	−25 to +85℃
				X5R	±15%	25℃	−55 to +85℃
B7			X7R	±15%	25℃	−55 to +125℃	
C6			X6S	±22%	25℃	−55 to +105℃	
C7			X7S	±22%	25℃	−55 to +125℃	
LD(※)			X5R	±15%	25℃	−55 to +85℃	
F			F	+30/−80%	20℃	−25 to +85℃	
			Y5V	+22/−82%	25℃	−30 to +85℃	
Note : ※LD Low distortion high value multilayer ceramic capacitor							
Test Methods and Remarks	Class 1 Capacitance at 20℃ and 85℃ shall be measured in thermal equilibrium, and the temperature characteristic shall be calculated from the following equation. $\frac{(C_{85}-C_{20})}{C_{20} \times \Delta T} \times 10^6 (\text{ppm}/^{\circ}\text{C})$ $\Delta T=65$						
	Class 2 Capacitance at each step shall be measured in thermal equilibrium, and the temperature characteristic shall be calculated from the following equation.						
	Step	B、F		X5R、X7R、X6S、X7S、Y5V			
	1	Minimum operating temperature					
	2	20℃		25℃			
	3	Maximum operating temperature					

	$\frac{(C - C_2)}{C_2} \times 100 (\%)$ <p>C : Capacitance in Step 1 or Step 3 C2 : Capacitance in Step 2</p>
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9. Deflection

Specified Value	Temperature Compensating (Class1)	Standard	Appearance : No abnormality Capacitance change : Within $\pm 5\%$ or ± 0.5 pF, whichever is larger.
		High Frequency Type	Appearance : No abnormality Capacitance change : Within ± 0.5 pF
	High Permittivity (Class2)		Appearance : No abnormality Capacitance change : Within $\pm 12.5\%$ (BJ, B7, C6, C7, LD(※)) Within $\pm 30\%$ (F) Note: ※LD Low distortion high value multilayer ceramic capacitor

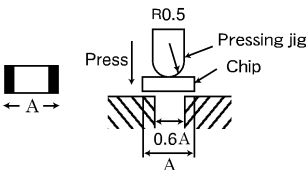
Test Methods and Remarks		Multilayer Ceramic Capacitors	
		042, 063, ※105 Type	The other types
	Board	Glass epoxy-resin substrate	
	Thickness	0.8mm	1.6mm
	Warp	1mm (Soft Termination type:3mm)	
	Duration	10 sec.	
	※1: 105 Type thickness, C: 0.2mm ,P: 0.3mm.		



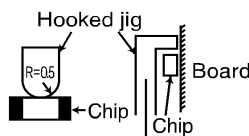
(Unit: mm)

Capacitance measurement shall be conducted with the board bent

10. Body Strength

Specified Value	Temperature Compensating (Class1)	Standard	—
		High Frequency Type	No mechanical damage.
	High Permittivity (Class2)		—
Test Methods and Remarks	<p>High Frequency Type Applied force : 5N Duration : 10 sec.</p> 		

11. Adhesive Strength of Terminal Electrodes

Specified Value	Temperature Compensating (Class1)	Standard	No terminal separation or its indication.
		High Frequency Type	
	High Permittivity (Class2)		
Test Methods and Remarks		Multilayer Ceramic Capacitors	
		042, 063 Type	105 Type or more
	Applied force	2N	5N
	Duration	30±5 sec.	
			

12. Solderability

Specified Value	Temperature Compensating(Class1)	Standard	At least 95% of terminal electrode is covered by new solder.
		High Frequency Type	
	High Permittivity (Class2)		
Test Methods and Remarks		Eutectic solder	Lead-free solder
	Solder type	H60A or H63A	Sn-3.0Ag-0.5Cu
	Solder temperature	230±5℃	245±3℃
	Duration	4±1 sec.	

13. Resistance to Soldering

Specified Value	Temperature Compensating(Class1)	Standard	Appearance : No abnormality Capacitance change : Within $\pm 2.5\%$ or $\pm 0.25\text{pF}$, whichever is larger. Q : Initial value Insulation resistance : Initial value Withstanding voltage (between terminals) : No abnormality
		High Frequency Type	Appearance : No abnormality Capacitance change : Within $\pm 2.5\%$ Q : Initial value Insulation resistance : Initial value Withstanding voltage (between terminals) : No abnormality
	High Permittivity (Class2) Note 1		Appearance : No abnormality Capacitance change : Within $\pm 7.5\%$ (BJ, B7, C6, C7, LD(※)) Within $\pm 20\%$ (F) Dissipation factor : Initial value Insulation resistance : Initial value Withstanding voltage (between terminals): No abnormality Note: ※LD Low distortion high value multilayer ceramic capacitor

Test Methods and Remarks			Iss 1	
			042, 063 Type	105 Type
	Preconditioning	None		
	Preheating	150°C, 1 to 2 min.	80 to 100°C, 2 to 5 min. 150 to 200°C, 2 to 5 min.	
	Solder temp.	270±5°C		
	Duration	3±0.5 sec.		
	Recovery	6 to 24 hrs (Standard condition) Noe 5		
			Class 2	
			042、063 Type	105, 107, 212 Type
	Preconditioning	Thermal treatment (at 150°C for 1 hr) Note 2		
	Preheating	150°C, 1 to 2 min.	80 to 100°C, 2 to 5 min. 150 to 200°C, 2 to 5 min.	80 to 100°C, 5 to 10 min. 150 to 200°C, 5 to 10 min.
	Solder temp.	270±5°C		
	Duration	3±0.5 sec.		
Recovery	24±2 hrs (Standard condition) Note 5			

14. Temperature Cycle (Thermal Shock)

Specified Value	Temperature Compensating (Class1)	Standard	Appearance : No abnormality Capacitance change : Within $\pm 2.5\%$ or $\pm 0.25\text{pF}$, whichever is larger. Q : Initial value Insulation resistance : Initial value Withstanding voltage (between terminals) : No abnormality
		High Frequency Type	Appearance : No abnormality Capacitance change : Within $\pm 0.25\text{pF}$ Q : Initial value Insulation resistance : Initial value Withstanding voltage (between terminals) : No abnormality
	High Permittivity (Class2) Note 1		Appearance : No abnormality Capacitance change : Within $\pm 7.5\%$ (BJ, B7, C6, C7, LD(※)) Within $\pm 20\%$ (F) Dissipation factor : Initial value Insulation resistance : Initial value Withstanding voltage (between terminals) : No abnormality Note: ※LD Low distortion high value multilayer ceramic capacitor

Test Methods and Remarks		Class 1	Class 2															
	Preconditioning	None	Thermal treatment (at 150°C for 1 hr) Note 2															
	1 cycle	<table><tr><td>Step</td><td>Temperature (°C)</td><td>Time (min.)</td></tr><tr><td>1</td><td>Minimum operating temperature</td><td>30±3</td></tr><tr><td>2</td><td>Normal temperature</td><td>2 to 3</td></tr><tr><td>3</td><td>Maximum operating temperature</td><td>30±3</td></tr><tr><td>4</td><td>Normal temperature</td><td>2 to 3</td></tr></table>		Step	Temperature (°C)	Time (min.)	1	Minimum operating temperature	30±3	2	Normal temperature	2 to 3	3	Maximum operating temperature	30±3	4	Normal temperature	2 to 3
	Step	Temperature (°C)	Time (min.)															
	1	Minimum operating temperature	30±3															
	2	Normal temperature	2 to 3															
	3	Maximum operating temperature	30±3															
4	Normal temperature	2 to 3																
Number of cycles	5 times																	
Recovery	6 to 24 hrs (Standard condition) Note 5	24±2 hrs (Standard condition) Note 5																

► This catalog contains the typical specification only due to the limitation of space. When you consider the purchase of our products, please check our specification. For details of each product (characteristics graph, reliability information, precautions for use, and so on), see our Web site (<http://www.tv-top.com/>).

15. Humidity (Steady State)

Specified Value	Temperature Compensating (Class1)	Standard	Appearance : No abnormality Capacitance change : Within $\pm 5\%$ or $\pm 0.5\text{pF}$, whichever is larger. Q : $C < 10\text{pF} : Q \geq 200 + 10C$ $10 \leq C < 30\text{pF} : Q \geq 275 + 2.5C$ $C \geq 30\text{pF} : Q \geq 350$ (C: Nominal capacitance) Insulation resistance : $1000 \text{ M}\Omega \text{ min.}$
		High Frequency Type	Appearance : No abnormality Capacitance change : Within $\pm 0.5\text{pF}$, Insulation resistance : $1000 \text{ M}\Omega \text{ min.}$
	High Permittivity (Class2) Note 1		Appearance : No abnormality Capacitance change : Within $\pm 12.5\%$ (BJ, B7, C6, C7, LD(※)) Within $\pm 30\%$ (F) Dissipation factor : 5.0% max. (BJ, B7, C6, C7, LD(※)) 11.0% max. (F) Insulation resistance : $50 \text{ M}\Omega \mu\text{F}$ or $1000 \text{ M}\Omega$ whichever is smaller. Note: ※LD Low distortion high value multilayer ceramic capacitor

Test Methods and Remarks		Class 1		Class 2
		Standard	High Frequency Type	All items
	Preconditioning	None		Thermal treatment (at 150°C for 1 hr) Note 2
	Temperature	$40 \pm 2^\circ\text{C}$	$60 \pm 2^\circ\text{C}$	$40 \pm 2^\circ\text{C}$
	Humidity	90 to 95%RH		90 to 95%RH
	Duration	$500 + 24 / - 0$ hrs		$500 + 24 / - 0$ hrs
	Recovery	6 to 24 hrs (Standard condition) Note 5		24 ± 2 hrs (Standard condition) Note 5

16. Humidity Loading

Specified Value	Temperature Compensating (Class1)	Standard	Appearance : No abnormality Capacitance change : Within $\pm 7.5\%$ or $\pm 0.75\text{pF}$, whichever is larger. Q : $C < 30\text{pF} : Q \geq 100 + 10C/3$ $C \geq 30\text{pF} : Q \geq 200$ (C: Nominal capacitance) Insulation resistance : $500 \text{ M}\Omega \text{ min.}$
		High Frequency Type	Appearance : No abnormality Capacitance change : $C \leq 2\text{pF} : \text{Within } \pm 0.4 \text{ pF}$ $C > 2\text{pF} : \text{Within } \pm 0.75 \text{ pF}$ (C: Nominal capacitance) Insulation resistance : $500 \text{ M}\Omega \text{ min.}$
	High Permittivity (Class2) Note 1		Appearance : No abnormality Capacitance change : Within $\pm 12.5\%$ (BJ, B7, C6, C7, LD(※)) Within $\pm 30\%$ (F) Dissipation factor : 5.0% max. (BJ, B7, C6, C7, LD(※)) 11.0% max. (F) Insulation resistance : $25 \text{ M}\Omega \mu\text{F}$ or $500 \text{ M}\Omega$, whichever is smaller. Note: ※LD Low distortion high value multilayer ceramic capacitor

Test Methods and Remarks		Class 1		Class 2
		Standard	High Frequency Type	All items
	Preconditioning	None		Voltage treatment (Rated voltage are applied for 1 hour at 40°C) Note 3
	Temperature	$40 \pm 2^\circ\text{C}$	$60 \pm 2^\circ\text{C}$	$40 \pm 2^\circ\text{C}$
	Humidity	90 to 95%RH		90 to 95%RH
	Duration	$500 + 24 / - 0$ hrs		$500 + 24 / - 0$ hrs
	Applied voltage	Rated voltage		Rated voltage
	Charge/discharge current	50mA max.		50mA max.
	Recovery	6 to 24 hrs (Standard condition) Note 5		24 ± 2 hrs (Standard condition) Note 5

17. High Temperature Loading

Specified Value	Temperature Compensating (Class1)	Standard	Appearance : No abnormality Capacitance change : Within $\pm 3\%$ or $\pm 0.3\text{pF}$, whichever is larger. Q : $C < 10\text{pF}$: $Q \geq 200 + 10C$ $10 \leq C < 30\text{pF}$: $Q \geq 275 + 2.5C$ $C \geq 30\text{pF}$: $Q \geq 350$ (C: Nominal capacitance) Insulation resistance : $1000 \text{ M}\Omega$ min.
		High Frequency Type	Appearance : No abnormality Capacitance change : Within $\pm 3\%$ or $\pm 0.3\text{pF}$, whichever is larger. Insulation resistance : $1000 \text{ M}\Omega$ min.
	High Permittivity (Class2) Note 1		Appearance : No abnormality Capacitance change : Within $\pm 12.5\%$ (BJ, B7, C6, C7, LD(※)) Within $\pm 30\%$ (F) Dissipation factor : 5.0% max. (BJ, B7, C6, C7, LD(※)) 11.0% max. (F) Insulation resistance : $50 \text{ M}\Omega \mu\text{F}$ or $1000 \text{ M}\Omega$, whichever is smaller. Note: ※LD Low distortion high value multilayer ceramic capacitor

Test Methods and Remarks		Class 1		Class 2		
		Standard	High Frequency Type	BJ, LD(※), F	C6	B7, C7
	Preconditioning	None		Voltage treatment (Twice the rated voltage shall be applied for 1 hour at 85°C, 105°C or 125°C) Note 3, 4		
	Temperature	Maximum operating temperature		Maximum operating temperature		
	Duration	1000+48/—0 hrs		1000+48/—0 hrs		
	Applied voltage	Rated voltage × 2		Rated voltage × 2 Note 4		
	Charge/discharge current	50mA max.		50mA max.		
	Recovery	6 to 24hr (Standard condition) Note 5		24±2 hrs (Standard condition) Note 5		
	Note: ※LD Low distortion high value multilayer ceramic capacitor					

Note 1 The figures indicate typical specifications. Please refer to individual specifications in detail.

Note 2 Thermal treatment : Initial value shall be measured after test sample is heat-treated at $150 \pm 0 / - 10^\circ\text{C}$ for an hour and kept at room temperature for 24 ± 2 hours.

Note 3 Voltage treatment : Initial value shall be measured after test sample is voltage-treated for an hour at both the temperature and voltage specified in the test conditions, and kept at room temperature for 24 ± 2 hours.

Note 4 150% of rated voltage is applicable to some items. Please refer to their specifications for further information.

Note 5 Standard condition: Temperature: 5 to 35°C , Relative humidity: 45 to 85% RH, Air pressure: 86 to 106kPa When there are questions concerning measurement results, in order to provide correlation data, the test shall be conducted under the following condition.

Temperature: $20 \pm 2^\circ\text{C}$, Relative humidity: 60 to 70% RH, Air pressure: 86 to 106kPa Unless otherwise specified, all the tests are conducted under the "standard condition".

Medium-High Voltage Multilayer Ceramic Capacitor

RELIABILITY DATA

1. Operating Temperature Range

Specified Value	X7R, X7S	: -55 to +125°C
	X5	: -55 to +85°C
	B	: -25 to +85°C

2. Storage Temperature Range

Specified Value	X7R, X7S	: -55 to +125°C
	X5R	: -55 to +85°C
	B	: -25 to +85°C

3. Rated Voltage

Specified Value	100VDC(HMK), 250VDC(QMK), 630VDC(SMK)
-----------------	---------------------------------------

4. Withstanding Voltage (Between terminals)

Specified Value	No breakdown or damage	
Test Methods and Remarks	Applied voltage	: Rated voltage × 2.5 (HMK), Rated voltage × 2 (QMK), Rated voltage × 1.2 (SMK)
	Duration	: 1 to 5sec.
	Charge/discharge current	: 50mA max.

5. Insulation Resistance

Specified Value	100MΩ μ F or 10GΩ, whichever is smaller.	
Test Methods and Remarks	Applied voltage	: Rated voltage (HMK, QMK), 500V (SMK)
	Duration	: 60±5sec.
	Charge/discharge current	: 50mA max.

6. Capacitance (Tolerance)

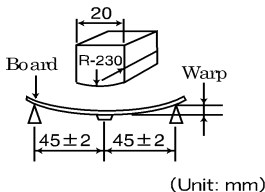
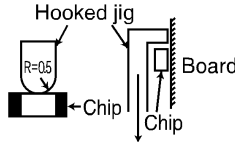
Specified Value	±10%, ±20%	
Test Methods and Remarks	Masuring frequency	: 1kHz ±10%
	Measuring voltage	: 1±0.2Vrms
	Bias application	: None

7. Dissipation Factor

Specified Value	3.5%max (HMK)	
	2.5%max (QMK, SMK)	
Test Methods and Remarks	Measuring frequency	: 1kHz ±10%
	Measuring voltage	: 1±0.2Vrms
	Bias application	: None

8. Temperature Characteristic of Capacitance

Specified Value	B : ±10% (−25 to +85°C) X5R : ±15% (−55 to +85°C) X7R : ±15% (−55 to +125°C) X7S : ±22% (−55 to +125°C)		
Test Methods and Remarks	Capacitance value at each step shall be measured in thermal equilibrium, and the temperature characteristic shall be calculated from the following equation.		
	Step	B	X5R、X7R、X7S
	1	Minimum operating tempeature	
	2	20°C	25°C
	3	Maximum operating temperature	
	$\frac{(C-C_2)}{C_2} \times 100 (\%)$		
	C : Capacitance value in Step 1 or Step 3 C2 : Capacitance value in Step 2		

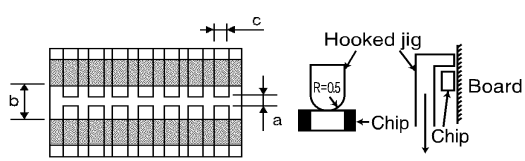
9. Deflection																	
Specified Value	Appearance : No abnormality Capacitance change : Within±10%																
Test Methods and Remarks	<div>Warp : 1mm (Soft Termination type:3mm) Duration : 10sec. Test board : Glass epoxy-resin substrate Thicknss : 1.6mm</div> <div> (Unit: mm)</div> <div>Capacitance measurement shall be conducted with the board bent.</div>																
10. Adhesive Strength of Terminal Electrodes																	
Specified Value	No terminal separation or its indication.																
Test Methods and Remarks	<div>Applied force : 5N Duration : 30±5sec.</div> <div></div>																
11. Solderability																	
Specified Value	At least 95% of terminal electrode is covered by new solder																
Test Methods and Remarks	<table><tr><td></td><td>Eutectic solder</td><td>Lead-free solder</td></tr><tr><td>Solder type</td><td>H60A or H63A</td><td>Sn-3.0Ag-0.5Cu</td></tr><tr><td>Solder temperature</td><td>230±5℃</td><td>245±3℃</td></tr><tr><td>Duration</td><td colspan="2">4±1 sec.</td></tr></table>			Eutectic solder	Lead-free solder	Solder type	H60A or H63A	Sn-3.0Ag-0.5Cu	Solder temperature	230±5℃	245±3℃	Duration	4±1 sec.				
	Eutectic solder	Lead-free solder															
Solder type	H60A or H63A	Sn-3.0Ag-0.5Cu															
Solder temperature	230±5℃	245±3℃															
Duration	4±1 sec.																
12. Resistance to Soldering																	
Specified Value	Appearance : No abnormality Capacitance change : Within±15%(HMK), ±10%(QMK, SMK) Dissipation factor : Initial value Insulation resistance : Initial value Withstanding voltage (between terminals) : No abnormality																
Test Methods and Remarks	Preconditioning : Thermal treatment(at 150℃ for 1hr) Note1 Solder temperature : 270±5℃ Duration : 3±0.5sec. Prehating conditions : 80 to 100℃, 2 to 5 min. 150 to 200℃, 2 to 5min. Recovery : 24±2hrs under the stadard condition Note3																
13. Temperature Cycle (Thermal Shock)																	
Specified Value	Appearance : No abnormality Capacitance change : Within±15%(HMK), ±7.5%(QMK, SMK) Dissipation factor : Initial value Insulation resistance : Initial value																
Test Methods and Remarks	Preconditioning : Thermal treatment (at 150℃ for 1hr) Note1 Conditions for 1 cycle <table><tr><td>Step</td><td>temperature(℃)</td><td>Time(min.)</td></tr><tr><td>1</td><td>Minimum operating temperature</td><td>30±3min.</td></tr><tr><td>2</td><td>Normal temperature</td><td>2 to 3min.</td></tr><tr><td>3</td><td>Maximum operating temperature</td><td>30±3min.</td></tr><tr><td>4</td><td>Normal temperature</td><td>2 to 3min.</td></tr></table> Number of cycles : 5 times Recovery : 24±2hrs under the standard condition Note3		Step	temperature(℃)	Time(min.)	1	Minimum operating temperature	30±3min.	2	Normal temperature	2 to 3min.	3	Maximum operating temperature	30±3min.	4	Normal temperature	2 to 3min.
Step	temperature(℃)	Time(min.)															
1	Minimum operating temperature	30±3min.															
2	Normal temperature	2 to 3min.															
3	Maximum operating temperature	30±3min.															
4	Normal temperature	2 to 3min.															

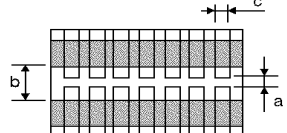
14. Humidity (Steady state)		
Specified Value	Appearance	: No abnormality
	Capacitance change	: Within $\pm 15\%$
	Dissipation factor	: $7\%_{\max}$ (HMK), $5\%_{\max}$ (QMK, SMK).
	Insulation resistance	: $25\text{M}\Omega \mu\text{F}$ or $1000\text{M}\Omega$, whichever is smaller.
Test Methods and Remarks	Preconditioning	: Thermal treatment (at 150°C for 1hr) Note1
	Temperature	: $40 \pm 2^{\circ}\text{C}$
	Humidity	: 90 to 95%RH
	Duration	: $500 + 24 / - 0$ hrs
	Recovery	: 24 ± 2 hrs under the standard condition Note3
15. Humidity Loading		
Specified Value	Appearance	: No abnormality
	Capacitance change	: Within $\pm 15\%$
	Dissipation factor	: $7\%_{\max}$ (HMK), $5\%_{\max}$ (QMK, SMK).
	Insulation resistance	: $10\text{M}\Omega \mu\text{F}$ or $500\text{M}\Omega$, whichever is smaller.
Test Methods and Remarks	According to JIS 5102 clause 9.9.	
	Preconditioning	: Voltage treatment Note2
	Temperature	: $40 \pm 2^{\circ}\text{C}$
	Humidity	: 90 to 95%RH
	Applied voltage	: Rated voltage
	Charge/discharge current	: 50mA max.
	Duration	: $500 + 24 / - 0$ hrs
	Recovery	: 24 ± 2 hrs under the standard condition Note3
16. High Temperature Loading		
Specified Value	Appearance	: No abnormality
	Capacitance change	: Within $\pm 15\%$
	Dissipation factor	: $7\%_{\max}$ (HMK), $5\%_{\max}$ (QMK, SMK).
	Insulation resistance	: $50\text{M}\Omega \mu\text{F}$ or $1000\text{M}\Omega$, whichever is smaller.
Test Methods and Remarks	According to JIS 5102 clause 9.10.	
	Preconditioning	: Voltage treatment Note2
	Temperature	: Maximum operating temperature
	Applied voltage	: Rated voltage $\times 2$ (HMK) Rated voltage $\times 1.5$ (QMK) Rated voltage $\times 1.2$ (SMK)
	Charge/discharge current	: 50mA max.
	Duration	: $1000 + 24 / - 0$ hrs
	Recovery	: 24 ± 2 hrs under the standard condition Note3
Note1 Thermal treatment : Initial value shall be measured after test sample is heat-treated at $150 \pm 0 / - 10^{\circ}\text{C}$ for an hour and kept at room temperature for 24 ± 2 hours.		
Note2 Voltage treatment : Initial value shall be measured after test sample is voltage-treated for an hour at both the temperature and voltage specified in the test conditions, and kept at room temperature for 24 ± 2 hours.		
Note3 Standard condition : Temperature: 5 to 35°C , Relative humidity: 45 to 85 % RH, Air pressure: 86 to 106kPa When there are questions concerning measurement results, in order to provide correlation data, the test shall be conducted under the following condition. Temperature: $20 \pm 2^{\circ}\text{C}$, Relative humidity: 60 to 70 % RH, Air pressure: 86 to 106kPa Unless otherwise specified, all the tests are conducted under the "standard condition".		

High Reliability Application Multilayer Ceramic Capacitors

■ RELIABILITY DATA

1. Operating Temperature Range	
Specified Value	X7R(−55°C to +125°C)
Test Methods and Remarks	Continuous use is available in this range. (reference temperature : 25°C)
2.Highest Operating temperature Range	
Specified Value	X7R(−55°C to +125°C)
Test Methods and Remarks	Maximum ambient temperature at which capacitors can be continuously used with rated voltage applied.
3. Rated Voltage	
Specified Value	Please refer to the page of the "PART NUMBERS".
Test Methods and Remarks	Continuous maximum applied voltage. If an AC voltage is loaded on a DC voltage, the sum of the two peak voltages should be lower than the rated voltage of the capacitor.
4. Shape and Dimensions	
Specified Value	Please refer to the page of the "EXTERNAL DIMENSIONS".
5. Heat Treatment (Class II)	
Test Methods and Remarks	Initial value shall be measured after test sample is heat-treated at 150±0/−10°C for an hour and kept at room temperature for 24 ± 2 hours.
6. Voltage Treatment (Class II)	
Test Methods and Remarks	Initial value shall be measured after test sample is voltage-treated for an hour at temperature and voltage which are specified as test conditions, and kept at room temperature for 24 ±2 hours.
7. Dielectric Withstanding Voltage (between terminals)	
Specified Value	No abnormality.
Test Methods and Remarks	Applied voltage : Rated voltage × 2.5 Duration : 1 to 5 seconds. Charging and discharging current shall be 50mA max.
8. Insulation Resistance	
Specified Value	Larger than whichever smaller of 500 MΩ · μF or 10 ⁴ MΩ
Test Methods and Remarks	Applied voltage : Rated voltage Duration : 60±5 seconds. Charging and discharging current shall be 50mA max.
9. Capacitance and Tolerance	
Specified Value	Please refer to the page of the "PART NUMBERS".
Test Methods and Remarks	Measurement frequency : 1KHz±10%(C≤10 μF) Measurement voltage : 1±0.2Vrms(C≤10 μF) 0.5±0.1V(6.3V rated voltage) Heat treatment specified in No.5 of the specification shall be conducted prior to measurement.
10. Q or Dissipation factor (tan δ)	
Specified Value	Please refer to the page of the "PART NUMBERS".
Test Methods and Remarks	Measurement frequency : 1KHz±10%(C≤10 μF) Measurement voltage : 1±0.2Vrms(C≤10 μF) 0.5±0.1V(6.3V rated voltage) Heat treatment specified in No.5 of the specification shall be conducted prior to measurement. NO DC bias is applied.

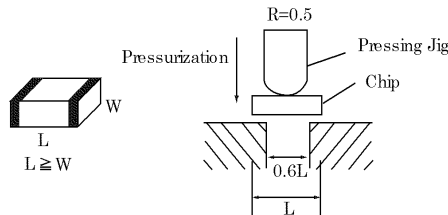
11. Temperature Characteristic (without DC bias)																																								
Specified Value	X7R(−55℃ to +125℃) : ±15%																																							
Test Methods and Remarks	<div>Confirming to EIA RS—198—D (1991) Heat treatment specified in No.5 of the specification shall be conducted prior to measurement. Change of the maximum capacitance deviation in step 1 to 5.</div> <table><tr><td>step</td><td>Temperature(℃)</td></tr><tr><td>1</td><td>+25</td></tr><tr><td>2</td><td>Minimum operating temperature</td></tr><tr><td>3</td><td>+25</td></tr><tr><td>4</td><td>Maximum operating temperature</td></tr><tr><td>5</td><td>+25</td></tr></table>	step	Temperature(℃)	1	+25	2	Minimum operating temperature	3	+25	4	Maximum operating temperature	5	+25																											
step	Temperature(℃)																																							
1	+25																																							
2	Minimum operating temperature																																							
3	+25																																							
4	Maximum operating temperature																																							
5	+25																																							
12. Adhesive Force of Terminal Electrodes																																								
Specified Value	Appearance : Terminal electrodes shall be no exfoliation or a sign of exfoliation.																																							
Test Methods and Remarks	<div>Solder lands refer to fig.1.</div> <table><tr><td></td><td>1608 size</td><td>larger than 2012 size</td></tr><tr><td>Applying force</td><td>5N</td><td>10N</td></tr><tr><td>Duration</td><td colspan="2">30±5 seconds.</td></tr><tr><td>Board</td><td colspan="2">Glass epoxy-resin substrate</td></tr><tr><td>Thickness</td><td colspan="2">1.6mm</td></tr></table> <div><table><tr><td rowspan="2">Dimension</td><td colspan="4">Case size</td></tr><tr><td>1608</td><td>2012</td><td>3216</td><td>3225</td></tr><tr><td>a</td><td>1.0</td><td>1.2</td><td>2.2</td><td>2.2</td></tr><tr><td>b</td><td>3.0</td><td>4.0</td><td>5.0</td><td>5.0</td></tr><tr><td>c</td><td>1.2</td><td>1.65</td><td>2.0</td><td>2.9</td></tr></table></div> <div>Fig.1</div>		1608 size	larger than 2012 size	Applying force	5N	10N	Duration	30±5 seconds.		Board	Glass epoxy-resin substrate		Thickness	1.6mm		Dimension	Case size				1608	2012	3216	3225	a	1.0	1.2	2.2	2.2	b	3.0	4.0	5.0	5.0	c	1.2	1.65	2.0	2.9
	1608 size	larger than 2012 size																																						
Applying force	5N	10N																																						
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Thickness	1.6mm																																							
Dimension	Case size																																							
	1608	2012	3216	3225																																				
a	1.0	1.2	2.2	2.2																																				
b	3.0	4.0	5.0	5.0																																				
c	1.2	1.65	2.0	2.9																																				
13. Vibration																																								
Specified Value	<div>Appearance : No abnormality.</div> <div>Capacitance change : Initial value shall be satisfied.</div> <div>Dissipation factor : Initial value shall be satisfied.</div> <div>Insulation resistance : Initial value shall be satisfied.</div>																																							
Test Methods and Remarks	<div>Heat treatment specified in No.5 of the specification shall be conducted prior to test. Measurement shall be conducted after test sample is heat treated as specified in No.5.</div> <div>Solder lands refer to figure 1.</div> <div>Direction of the vibration test : X, Y, Z each of 3 orientations for 2 hours respectively (total 6 hours)</div> <div>Vibration frequency : 10 to 55 to 10Hz (1 minutes each)</div> <div>Total amplitude : 1.5 mm</div> <div>Measurement after the test shall be made after test sample is kept at room temperature for 24 ±2 hours.</div>																																							
14. Resistance to Soldering Heat																																								
Specified Value	<div>Appearance : No abnormality</div> <div>Capacitance change : ≤ ±7.5%</div> <div>Dissipation factor : Initial value shall be satisfied.</div> <div>Insulation resistance : Initial value shall be satisfied.</div> <div>Dielectric withstanding voltage (between terminals) : No abnormality</div>																																							
Test Methods and Remarks	<div>Heat treatment specified in No.5 of the specification shall be conducted prior to test.</div> <div>Immerse test sample in an solder solution (Sn-3Ag-0.5Cu).</div> <div>Soldering temperature : 270℃±5℃</div> <div>Duration : 3±0.5 seconds</div> <div>Soaking position : Test sample is soaked until the terminal electrode is covered in solder solution.</div> <div>Preheating condition : 3216 size or smaller size: 120 to 150℃ for 1 minute, 3225 size: 100 to 120℃ for 1 minute, 170 to 200℃ for 1 minute.</div> <div>Measurement after the test shall be made after test sample is kept at room temperature for 24 ±2 hours.</div>																																							
15. Solderability																																								
Specified Value	More than 95% of terminal electrode shall be covered with fresh solder.																																							
Test Methods and Remarks	<div>Heat treatment specified in No.5 of the specification shall be conducted prior to test.</div> <div>Immerse test sample in an solder solution (Sn-3Ag-0.5Cu).</div> <div>Soldering temperature : 245℃±5℃</div> <div>Duration : 4±1 seconds</div> <div>Dipping position : Test sample is immersed until the terminal electrode is covered in solder solution.</div>																																							

16. Thermal shock																											
Specified Value	Appearance : No abnormality																										
	Capacitance change : $\leq \pm 7.5\%$																										
	Dissipation factor : Initial value shall be satisfied.																										
	Insulation resistance : Initial value shall be satisfied.																										
	Dielectric withstanding voltage (between terminals) : No abnormality																										
Test Methods and Remarks	Heat treatment specified in No.5 of the specification shall be conducted prior to test. Measurement shall be conducted after test sample is heat treated as specified in No.5. condition of the one cycle (Air—Air)																										
	Step	Temperature (°C)	Time (min.)	Transfer time																							
	1	Minimum usage temperature	15	within 20 seconds																							
	2	Maximum usage temperature	15	within 20 seconds																							
	Test cycles: 100 times. Measurement after the test shall be made after test sample is kept at room temperature for 24 ± 2 hours.																										
		<table><tr><th rowspan="2">Dimension</th><th colspan="4">Case size</th></tr><tr><th>1608</th><th>2012</th><th>3216</th><th>3225</th></tr><tr><td>a</td><td>0.6</td><td>0.8</td><td>2.0</td><td>2.0</td></tr><tr><td>b</td><td>2.2</td><td>3.0</td><td>4.4</td><td>4.4</td></tr><tr><td>c</td><td>0.9</td><td>1.3</td><td>1.7</td><td>2.6</td></tr></table>		Dimension	Case size				1608	2012	3216	3225	a	0.6	0.8	2.0	2.0	b	2.2	3.0	4.4	4.4	c	0.9	1.3	1.7	2.6
Dimension	Case size																										
	1608	2012	3216	3225																							
a	0.6	0.8	2.0	2.0																							
b	2.2	3.0	4.4	4.4																							
c	0.9	1.3	1.7	2.6																							
Fig.2																											

17. Humidity Loading																																							
Specified Value Note1	Appearance	: No abnormality																																					
Capacitance change	: $\pm 12.5\%$																																						
Dissipation factor	: 5.0%max.																																						
Insulation resistance	: Larger than whichever smaller of $25M\Omega \cdot \mu F$ or $500M\Omega$																																						
Test Methods and Remarks	Test condition	: $85^{\circ}\text{C}/85\%\text{RH}$.																																					
Duration	: $1000 + 48/-0$ hours.																																						
DC bias	: Applied rated voltage.																																						
Voltage treatment specified in No.6 of the specification shall be conducted prior to test.																																							
Measurement after the test shall be made after test sample is kept at room temperature for 24 ± 2 hours.																																							
18. High Temperature Loading																																							
Specified Value Note1	Appearance	: No abnormality																																					
Capacitance change	: $\leq \pm 12.5\%$																																						
Dissipation factor	: 5.0%max.																																						
Insulation resistance	: Larger than whichever smaller of $25M\Omega \cdot \mu F$ or $500M\Omega$																																						
Test Methods and Remarks	Voltage treatment specified in No.6 of the specification shall be conducted prior to test.																																						
Test sample shall be put in thermostatic oven with maximum temperature.																																							
Applied voltage	: Rated voltage x 2																																						
Duration	: $1000 + 48/-0$ hours.																																						
Charging and discharging current shall be 50mA or less.																																							
Measurement after the test shall be made after test sample is kept at room temperature for 24 ± 2 hours.																																							
19. Resistance to Flexure of substrate																																							
Specified Value	Appearance	: No abnormality																																					
Capacitance change	: $\leq \pm 12.5\%$																																						
Dissipation factor	: 5.0%max.																																						
Insulation resistance	: Initial value shall be satisfied.																																						
Test Methods and Remarks	Warp	: 1mm																																					
Testing board	: Grass epoxy - resin substrate																																						
Thickness	: 1.6mm																																						
Test board and solder lands	: Refer to fig. 3.																																						
			Dimension	Case size					-----------	-----------	------	------	------			1608	2012	3216	3225		a	0.6	0.8	2.0	2.0		b	2.2	3.0	4.4	4.4		c	0.9	1.3	1.7	2.6		
Fig.3																																							
		Fig.4																																					
Measurement shall be made with board in the bent position. (fig.4)																																							

20. High Temperature Exposure		
Specified Value Note1	Appearance : No abnormality Capacitance change : $\leq \pm 12.5\%$ Dissipation factor : 5.0%max. Insulation resistance : Larger than whichever smaller of $500\text{M}\Omega \cdot \mu\text{F}$ or $10000\text{M}\Omega$	
Test Methods and Remarks	Heat treatment specified in No.5 of the specification shall be conducted prior to test. Test sample shall be put in thermostatic oven with maximum temperature. Duration : 1000 +48/—0 hours. Initial value shall be measured after test sample is heat—treated specified No.5. Measurement after the test shall be made after test sample is kept at room temperature for 24 ± 2 hours.	

21. Temperature Cycling		
Specified Value Note1	Appearance : No abnormality Capacitance change : $\leq \pm 7.5\%$ Dissipation factor : Initial value shall be satisfied Insulation resistance : Initial value shall be satisfied	
Test Methods and Remarks	Heat treatment specified in No.5 of the specification shall be conducted prior to test. Measurement shall be conducted after test sample is heat treated as specified in No.5. condition of the one cycle	
	Step	Temperature(°C)
	1	Minimum usage temperature
	2	+25
	3	Maximum usage temperature
	4	+25
	Time(min.)	
		30 ± 3
		2 to 3
		30 ± 3
		2 to 3
	Test cycles:200 times Solder lands refer to fig. 2. Measurement after the test shall be made after test sample is kept at room temperature for 24 ± 2 hours.	

22. Body strength	
Specified Value	No mechanical damage
Test Methods and Remarks	Applying force : 10N Applying time : 10 seconds 

Note 1 The figures indicate typical specifications. Please refer to individual specifications in detail.

Note 1 The figures indicate typical specifications. Please refer to individual specifications in detail.

Precautions on the use of Multilayer Ceramic Capacitors

■ PRECAUTIONS

1. Circuit Design

Precautions	<p>◆Verification of operating environment, electrical rating and performance</p> <p>1. A malfunction of equipment in fields such as medical, aerospace, nuclear control, etc. may cause serious harm to human life or have severe social ramifications.</p> <p>Therefore, any capacitors to be used in such equipment may require higher safety and reliability, and shall be clearly differentiated from them used in general purpose applications.</p>
	<p>◆Operating Voltage (Verification of Rated voltage)</p> <p>1. The operating voltage for capacitors must always be their rated voltage or less.</p> <p>If an AC voltage is loaded on a DC voltage, the sum of the two peak voltages shall be the rated voltage or less.</p> <p>For a circuit where an AC or a pulse voltage may be used, the sum of their peak voltages shall also be the rated voltage or less.</p> <p>2. Even if an applied voltage is the rated voltage or less reliability of capacitors may be deteriorated in case that either a high frequency AC voltage or a pulse voltage having rapid rise time is used in a circuit.</p>

2. PCB Design

Precautions	<p>◆Pattern configurations (Design of Land-patterns)</p> <p>1. When capacitors are mounted on PCBs, the amount of solder used (size of fillet) can directly affect the capacitor performance.</p> <p>Therefore, the following items must be carefully considered in the design of land patterns:</p> <p>(1) Excessive solder applied can cause mechanical stresses which lead to chip breaking or cracking. Therefore, please consider appropriate land-patterns for proper amount of solder.</p> <p>(2) When more than one component are jointly soldered onto the same land, each component's soldering point shall be separated by solder-resist.</p>
	<p>◆Pattern configurations (Capacitor layout on PCBs)</p> <p>After capacitors are mounted on boards, they can be subjected to mechanical stresses in subsequent manufacturing processes (PCB cutting, board inspection, mounting of additional parts, assembly into the chassis, wave soldering of the boards, etc.). For this reason, land pattern configurations and positions of capacitors shall be carefully considered to minimize stresses.</p>

◆Pattern configurations (Design of Land-patterns)
The following diagrams and tables show some examples of recommended land patterns to prevent excessive solder amounts.

(1) Recommended land dimensions for typical chip capacitors

●Multilayer Ceramic Capacitors : Recommended land dimensions

(unit: mm)

Wave-soldering

Type		107	212	316	325
Size	L	1.6	2.0	3.2	3.2
	W	0.8	1.25	1.6	2.5
A		0.8 to 1.0	1.0 to 1.4	1.8 to 2.5	1.8 to 2.5
B		0.5 to 0.8	0.8 to 1.5	0.8 to 1.7	0.8 to 1.7
C		0.6 to 0.8	0.9 to 1.2	1.2 to 1.6	1.8 to 2.5

Reflow-soldering

Type	042	063	105	107	212	316	325	432
Size	L	0.4	0.6	1.0	1.6	2.0	3.2	4.5
	W	0.2	0.3	0.5	0.8	1.25	1.6	3.2
A	0.15 to 0.25	0.20 to 0.30	0.45 to 0.55	0.8 to 1.0	0.8 to 1.2	1.8 to 2.5	1.8 to 2.5	2.5 to 3.5
B	0.15 to 0.20	0.20 to 0.30	0.40 to 0.50	0.6 to 0.8	0.8 to 1.2	1.0 to 1.5	1.0 to 1.5	1.5 to 1.8
C	0.15 to 0.30	0.25 to 0.40	0.45 to 0.55	0.6 to 0.8	0.9 to 1.6	1.2 to 2.0	1.8 to 3.2	2.3 to 3.5

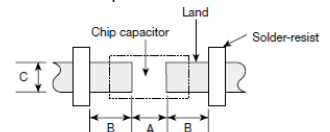
Note: Recommended land size might be different according to the allowance of the size of the product.

●LWDC: Recommended land dimensions for reflow-soldering

(unit: mm)

Type		105	107	212
Size	L	0.52	0.8	1.25
	W	1.0	1.6	2.0
A		0.18 to 0.22	0.25 to 0.3	0.5 to 0.7
B		0.2 to 0.25	0.3 to 0.4	0.4 to 0.5
C		0.9 to 1.1	1.5 to 1.7	1.9 to 2.1

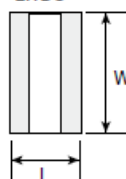
Land patterns for PCBs



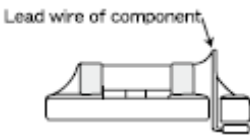
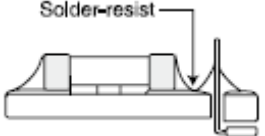
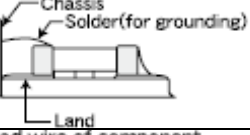
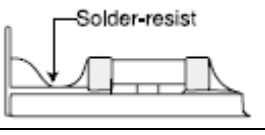
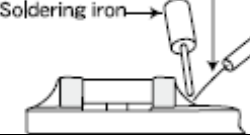
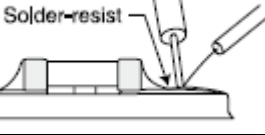
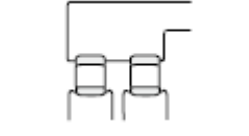
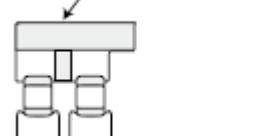
Chip capacitor



LWDC

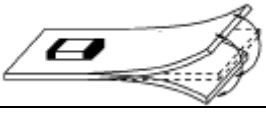
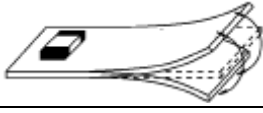


(2) Examples of good and bad solder application

Items	Not eommended	Recommended
Mixed mounting of SMD and leaded components		
Component placement close to the chassis		
Hand-soldering of leaded Components near mounted components		
Horizontal component placement		

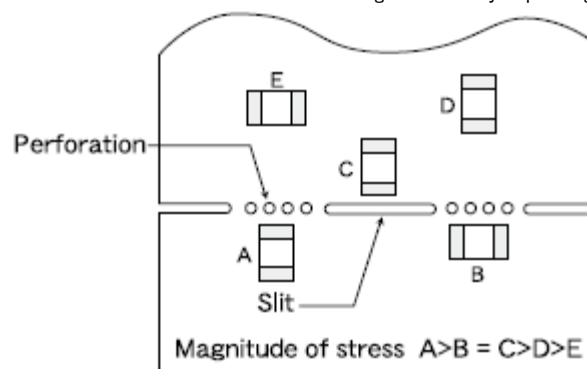
◆Pattern configurations (Capacitor layout on PCBs)

1-1. The following is examples of good and bad capacitor layouts ; capacitors shall be located to minimize any possible mechanical stresses from board warp or deflection.

Items	Not recommended	Recommended
Deflection of board		

Place the product at a right angle to the direction of the anticipated mechanical stress.

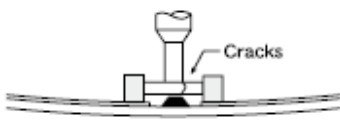

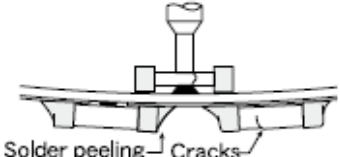
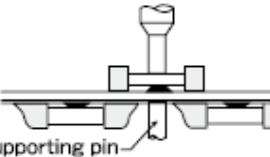
1-2. The amount of mechanical stresses given will vary depending on capacitor layout. Please refer to diagram below.



1-3. When PCB is split, the amount of mechanical stress on the capacitors can vary according to the method used. The following methods are listed in order from least stressful to most stressful: push-back, slit, V-grooving, and perforation. Thus, please consider the PCB, split methods as well as chip location.

3. Mounting

Precautions	<p>◆Adjustment of mounting machine</p> <ol style="list-style-type: none"> When capacitors are mounted on PCB, excessive impact load shall not be imposed on them. Maintenance and inspection of mounting machines shall be conducted periodically. <p>◆Selection of Adhesives</p> <ol style="list-style-type: none"> When chips are attached on PCBs with adhesives prior to soldering, it may cause capacitor characteristics degradation unless the following factors are appropriately checked : size of land patterns, type of adhesive, amount applied, hardening temperature and hardening period. Therefore, please contact us for further information.
	<p>◆Adjustment of mounting machine</p> <ol style="list-style-type: none"> When the bottom dead center of a pick-up nozzle is too low, excessive force is imposed on capacitors and causes damages. To avoid this, the following points shall be considerable. <ol style="list-style-type: none"> (1)The bottom dead center of the pick-up nozzle shall be adjusted to the surface level of PCB without the board deflection. (2)The pressure of nozzle shall be adjusted between 1 and 3 N static loads. (3)To reduce the amount of deflection of the board caused by impact of the pick-up nozzle, supporting pins or back-up pins shall be used on the other side of the PCB. The following diagrams show some typical examples of good and bad pick-up nozzle placement:

Items	Not recommended	Recommended
Single-sided mounting		
Double-sided mounting		

2. As the alignment pin is worn out, adjustment of the nozzle height can cause chipping or cracking of capacitors because of mechanical impact on the capacitors.
To avoid this, the monitoring of the width between the alignment pins in the stopped position, maintenance, check and replacement of the pin shall be conducted periodically.

◆ Selection of Adhesives

Some adhesives may cause IR deterioration. The different shrinkage percentage of between the adhesive and the capacitors may result in stresses on the capacitors and lead to cracking. Moreover, too little or too much adhesive applied to the board may adversely affect components. Therefore, the following precautions shall be noted in the application of adhesives.

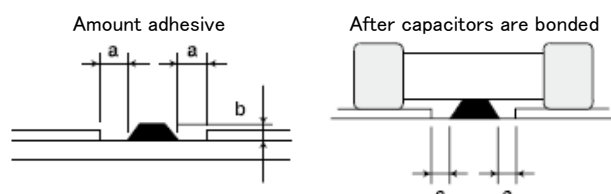
(1) Required adhesive characteristics

- The adhesive shall be strong enough to hold parts on the board during the mounting & solder process.
- The adhesive shall have sufficient strength at high temperatures.
- The adhesive shall have good coating and thickness consistency.
- The adhesive shall be used during its prescribed shelf life.
- The adhesive shall harden rapidly.
- The adhesive shall have corrosion resistance.
- The adhesive shall have excellent insulation characteristics.
- The adhesive shall have no emission of toxic gasses and no effect on the human body.

(2) The recommended amount of adhesives is as follows;

[Recommended condition]

Figure	212/316 case sizes as examples
a	0.3mm min
b	100 to 120 μ m
c	Adhesives shall not contact land



4. Soldering

◆ Selection of Flux

Since flux may have a significant effect on the performance of capacitors, it is necessary to verify the following conditions prior to use;

- Flux used shall be less than or equal to 0.1 wt% (in Cl equivalent) of halogenated content. Flux having a strong acidity content shall not be applied.
- When shall capacitors are soldered on boards, the amount of flux applied shall be controlled at the optimum level.
- When water-soluble flux is used, special care shall be taken to properly clean the boards.

Precautions

◆ Soldering

Temperature, time, amount of solder, etc. shall be set in accordance with their recommended conditions.

Sn-Zn solder paste can adversely affect MLCC reliability.

Please contact us prior to usage of Sn-Zn solder.

◆ Selection of Flux

- When too much halogenated substance (Chlorine, etc.) content is used to activate flux, or highly acidic flux is used, it may lead to corrosion of terminal electrodes or degradation of insulation resistance on the surfaces of the capacitors.
- Flux is used to increase solderability in wave soldering. However if too much flux is applied, a large amount of flux gas may be emitted and may adversely affect the solderability. To minimize the amount of flux applied, it is recommended to use a flux-bubbling system.
- Since the residue of water-soluble flux is easily dissolved in moisture in the air, the residues on the surfaces of capacitors in high humidity conditions may cause a degradation of insulation resistance and reliability of the capacitors. Therefore, the cleaning methods and the capability of the machines used shall also be considered carefully when water-soluble flux is used.

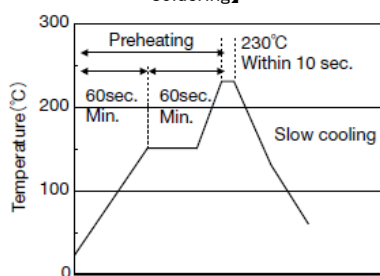
Technical considerations

◆ Soldering

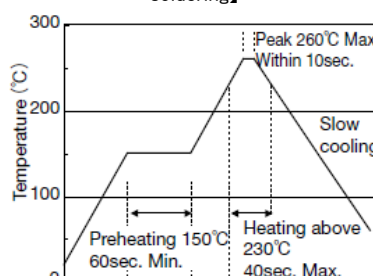
- Ceramic chip capacitors are susceptible to thermal shock when exposed to rapid or concentrated heating or rapid cooling.
- Therefore, the soldering must be conducted with great care so as to prevent malfunction of the components due to excessive thermal shock.
- Preheating : Capacitors shall be preheated sufficiently, and the temperature difference between the capacitors and solder shall be within 100 to 130°C.
- Cooling : The temperature difference between the capacitors and cleaning process shall not be greater than 100°C.

[Reflow soldering]

【Recommended conditions for eutectic soldering】

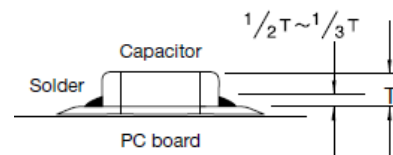


【Recommended condition for Pb-free soldering】



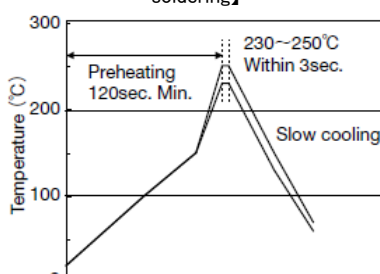
Caution

- ① The ideal condition is to have solder mass(fillet) controlled to 1/2 to 1/3 of the thickness of a capacitor.
- ② Because excessive dwell times can adversely affect solderability, soldering duration shall be kept as close to recommended times as possible.

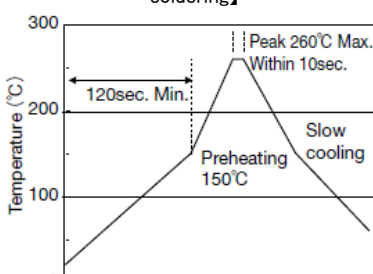


[Wave soldering]

【Recommended conditions for eutectic soldering】



【Recommended condition for Pb-free soldering】

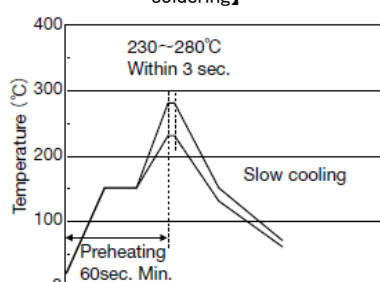


Caution

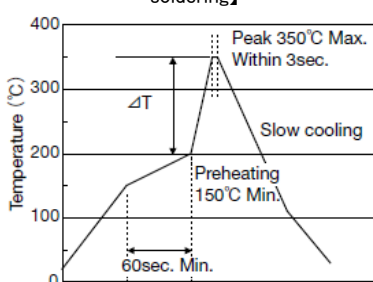
- ① Wave soldering must not be applied to capacitors designated as for reflow soldering only.

[Hand soldering]

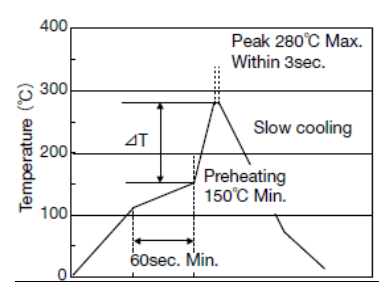
【Recommended conditions for eutectic soldering】



【Recommended condition for Pb-free soldering】



	ΔT
316type or less	$\Delta T \leq 150^{\circ}\text{C}$



	ΔT
325type or more	$\Delta T \leq 130^{\circ}\text{C}$

Caution

- ① Use a 50W soldering iron with a maximum tip diameter of 1.0 mm.
- ② The soldering iron shall not directly touch capacitors.

5. Cleaning

◆Cleaning conditions

1. When PCBs are cleaned after capacitors mounting, please select the appropriate cleaning solution in accordance with the intended use of the cleaning. (e.g. to remove soldering flux or other materials from the production process.)
2. Cleaning condition shall be determined after it is verified by using actual cleaning machine that the cleaning process does not affect capacitor's characteristics.

Precautions

1. The use of inappropriate cleaning solutions can cause foreign substances such as flux residue to adhere to capacitors or deteriorate their outer coating, resulting in a degradation of the capacitor's electrical properties (especially insulation resistance).
2. Inappropriate cleaning conditions (insufficient or excessive cleaning) may adversely affect the performance of the capacitors. In the case of ultrasonic cleaning, too much power output can cause excessive vibration of PCBs which may lead to the cracking of capacitors or the soldered portion, or decrease the terminal electrodes' strength. Therefore, the following conditions shall be carefully checked:
 Ultrasonic output : 20 W/l or less
 Ultrasonic frequency : 40 kHz or less
 Ultrasonic washing period : 5 min. or less

Technical considerations

6. Resin coating and mold	
Precautions	<p>1. With some type of resins, decomposition gas or chemical reaction vapor may remain inside the resin during the hardening period or while left under normal storage conditions resulting in the deterioration of the capacitor's performance.</p> <p>2. When a resin's hardening temperature is higher than capacitor's operating temperature, the stresses generated by the excessive heat may lead to damage or destruction of capacitors.</p> <p>The use of such resins, molding materials etc. is not recommended.</p>
7. Handling	
Precautions	<p>◆Splitting of PCB</p> <p>1. When PCBs are split after components mounting, care shall be taken so as not to give any stresses of deflection or twisting to the board.</p> <p>2. Board separation shall not be done manually, but by using the appropriate devices.</p> <p>◆Mechanical considerations</p> <p>Be careful not to subject capacitors to excessive mechanical shocks.</p> <p>(1) If ceramic capacitors are dropped onto a floor or a hard surface, they shall not be used.</p> <p>(2) Please be careful that the mounted components do not come in contact with or bump against other boards or components.</p>
8. Storage conditions	
Precautions	<p>◆Storage</p> <p>1. To maintain the solderability of terminal electrodes and to keep packaging materials in good condition, care must be taken to control temperature and humidity in the storage area. Humidity should especially be kept as low as possible.</p> <p>•Recommended conditions</p> <p>Ambient temperature : Below 30°C</p> <p>Humidity : Below 70% RH</p> <p>The ambient temperature must be kept below 40°C. Even under ideal storage conditions, solderability of capacitor is deteriorated as time passes, so capacitors shall be used within 6 months from the time of delivery.</p> <p>•Ceramic chip capacitors shall be kept where no chlorine or sulfur exists in the air.</p> <p>2. The capacitance values of high dielectric constant capacitors will gradually decrease with the passage of time, so care shall be taken to design circuits. Even if capacitance value decreases as time passes, it will get back to the initial value by a heat treatment at 150°C for 1 hour.</p>
Technical considerations	<p>If capacitors are stored in a high temperature and humidity environment, it might rapidly cause poor solderability due to terminal oxidation and quality loss of taping/packaging materials. For this reason, capacitors shall be used within 6 months from the time of delivery. If exceeding the above period, please check solderability before using the capacitors.</p>
<p>※RCR-2335B (Safety Application Guide for fixed ceramic capacitors for use in electronic equipment) is published by JEITA.</p> <p>Please check the guide regarding precautions for deflection test, soldering by spot heat, and so on.</p>	

Precautions on the use of High Reliability Application Multilayer Ceramic Capacitors

■ PRECAUTIONS

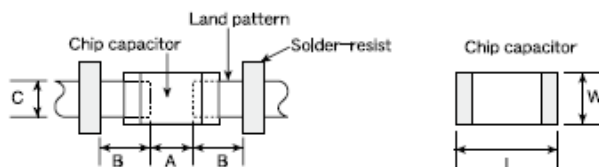
1. Circuit Design

Precautions	<p>◆ Verification of operating environment, electrical rating and performance</p> <ol style="list-style-type: none"> 1. A malfunction in medical equipment, spacecraft, nuclear reactors, etc. may cause serious harm to human life or have severe social ramifications. As such, any capacitors to be used in such equipment may require higher safety and/or reliability considerations and should be clearly differentiated from components used in general purpose applications. <p>◆ Operating Voltage (Verification of Rated voltage)</p> <ol style="list-style-type: none"> 1. The operating voltage for capacitors must always be lower than their rated values. If an AC voltage is loaded on a DC voltage, the sum of the two peak voltages should be lower than the rated value of the capacitor chosen. For a circuit where both an AC and a pulse voltage may be present, the sum of their peak voltages should also be lower than the capacitor's rated voltage. 2. Even if the applied voltage is lower than the rated value, the reliability of capacitors might be reduced if either a high frequency AC voltage or a pulse voltage having rapid rise time is present in the circuit.
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2. PCB Design

Precautions	<p>◆ Pattern configurations (Design of Land-patterns)</p> <ol style="list-style-type: none"> 1. When capacitors are mounted on a PCB, the amount of solder used (size of fillet) can directly affect capacitor performance. Therefore, the following items must be carefully considered in the design of solder land patterns: <ol style="list-style-type: none"> (1) The amount of solder applied can affect the ability of chips to withstand mechanical stresses which may lead to breaking or cracking. Therefore, when designing land-patterns it is necessary to consider the appropriate size and configuration of the solder pads which in turn determines the amount of solder necessary to form the fillets. (2) When more than one part is jointly soldered onto the same land or pad, the pad must be designed so that each component's soldering point is separated by solder-resist. <p>◆ Pattern configurations (Capacitor layout on panelized [breakaway] PC boards)</p> <ol style="list-style-type: none"> 1. After capacitors have been mounted on the boards, chips can be subjected to mechanical stresses in subsequent manufacturing processes (PCB cutting, board inspection, mounting of additional parts, assembly into the chassis, wave soldering the reflow soldered boards etc.) For this reason, planning pattern configurations and the position of SMD capacitors should be carefully performed to minimize stress.
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Technical considerations	<p>◆ Pattern configurations (Design of Land-patterns)</p> <ol style="list-style-type: none"> 1. The following diagrams and tables show some examples of recommended patterns to prevent excessive solder amounts. (larger fillets which extend above the component end terminations) Examples of improper pattern designs are also shown. <ol style="list-style-type: none"> (1) Recommended land dimensions for a typical chip capacitor land patterns for PCBs
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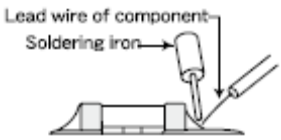
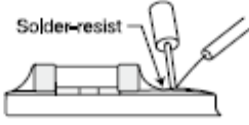
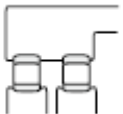
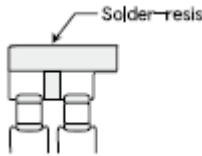
Recommended land dimensions for reflow-soldering (unit: mm)

Type		107	212	316	325
Size	L	1.6	2.0	3.2	3.2
	W	0.8	1.25	1.6	2.5
A		0.8~1.0	0.8~1.2	1.8~2.5	1.8~2.5
B		0.6~0.8	0.8~1.2	1.0~1.5	1.0~1.5
C		0.6~0.8	0.9~1.6	1.2~2.0	1.8~3.2

Excess solder can affect the ability of chips to withstand mechanical stresses. Therefore, please take proper precautions when designing land-patterns.



(2) Examples of good and bad solder application

Items	Not recommended	Recommended
Mixed mounting of SMD and leaded components	<p>Lead wire of component</p>	<p>Solder-resist</p>
Component placement close to the chassis	<p>Chassis Solder (for grounding) Electrode pattern</p>	<p>Solder-resist</p>

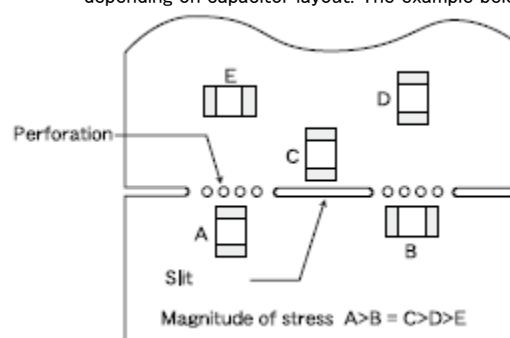
Hand-soldering of leaded components near mounted components		
Horizontal component placement		

◆Pattern configurations (Capacitor layout on panelized [breakaway] PC boards)

1-1. The following is examples of good and bad capacitor layout; SMD capacitors should be located to minimize any possible mechanical stresses from board warp or deflection.

Items	Not recommended	Recommended
Deflection of the board		 Place the product at a right angle to the direction of the anticipated mechanical stress.

1-2. To layout the capacitors for the breakaway PC board, it should be noted that the amount of mechanical stresses given will vary depending on capacitor layout. The example below shows recommendations for better design.



1-3. When breaking PC boards along their perforations, the amount of mechanical stress on the capacitors can vary according to the method used. The following methods are listed in order from least stressful: push-back, slit, V-grooving, and perforation. Thus, any ideal SMD capacitor layout must also consider the PCB splitting procedure.

3.Soldering

◆Selection of Flux

- Since flux may have a significant effect on the performance of capacitors, it is necessary to verify the following conditions prior to use;
 - Flux used should be with less than or equal to 0.1 wt% (equivalent to chlorine) of halogenated content. Flux having strong acidity content should not be applied.
 - When soldering capacitors on the board, the amount of flux applied should be controlled at the optimum level.
 - When using water-soluble flux, special care should be taken to properly clean the boards.

◆Soldering

- Temperature, time, amount of solder, etc. are specified in accordance with the following recommended conditions.
 - Sn-Zn solder paste can affect MLCC reliability performance.
 - Please contact us prior to usage.

◆Selection of Flux

- When too much halogenated substance (Chlorine, etc.) content is used to activate the flux, or highly acidic flux is used, an excessive amount of residue after soldering may lead to corrosion of the terminal electrodes or degradation of insulation resistance on the surface of the capacitors.
- Flux is used to increase solderability in flow soldering, but if too much is applied, a large amount of flux gas may be emitted and may detrimentally affect solderability. To minimize the amount of flux applied, it is recommended to use a flux-bubbling system.
- Since the residue of water-soluble flux is easily dissolved by water content in the air, the residue on the surface of capacitors in high humidity conditions may cause a degradation of insulation resistance and therefore affect the reliability of the components. The cleaning methods and the capability of the machines used should also be considered carefully when selecting water-soluble flux.

◆Soldering

- Preheating when soldering

Heating: Ceramic chip components should be preheated to within 100 to 130°C of the soldering.

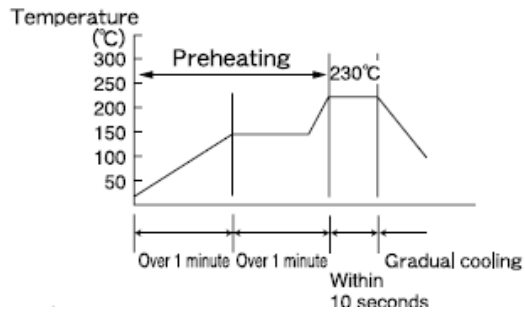
Cooling: The temperature difference between the components and cleaning process should not be greater than 100°C.

Ceramic chip capacitors are susceptible to thermal shock when exposed to rapid or concentrated heating or rapid cooling. Therefore, the soldering process must be conducted with great care so as to prevent malfunction of the components due to excessive thermal shock.

【Recommended conditions for soldering】

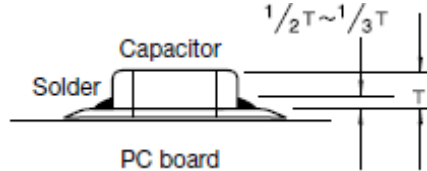
[Reflow soldering]

Temperature profile



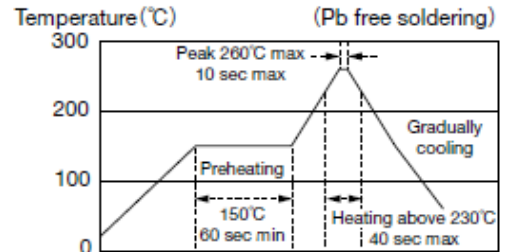
Caution

①The ideal condition is to have solder mass (fillet) controlled to $1/2 T \sim 1/3 T$ of the thickness of the capacitor, as shown below:



②Because excessive dwell times can detrimentally affect solderability, soldering duration should be kept as close to recommended times as possible.

【Recommended conditions for Pd Free soldering】



※Ceramic chip components should be preheated to within 100 to 130°C of the soldering.

※Assured to be reflow soldering for 2 times.